

(51) International Patent Classification⁵:

G06F 7/48

A1

(11) International Publication Number:

WO 96/08761

(43) International Publication Date:

21 March 1996 (21.03.96)

(21) International Application Number: PCT/US95/11589

(22) International Filing Date: 13 September 1995 (13.09.95)

(30) Priority Data:

08/307,932

16 September 1994 (16.09.94) US

(71) Applicant: THE RESEARCH FOUNDATION OF STATE UNIVERSITY OF NEW YORK [US/US]; Suite 200 UB Commons, State University Plaza, Amherst, NY 14228-2567 (US).

(72) Inventors: SRIDHAR, Ramalingam; 199 Brockmoore Drive, East Amherst, NY 14051 (US). ZHANG, Xuguang; 18946 Vickie Avenue, Cerritos, CA 90701 (US).

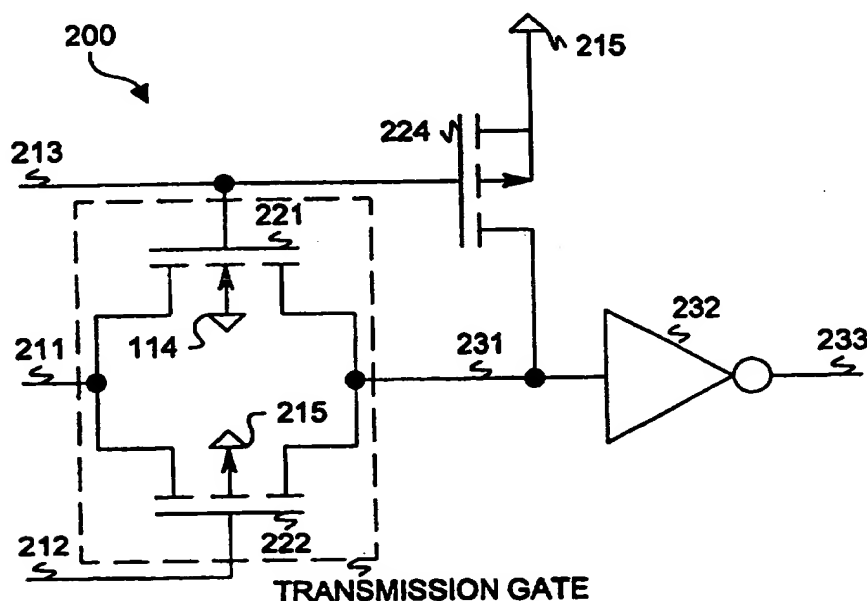
(74) Agent: VIKSNINS, Ann, S.; Schwegman, Lundberg & Woessner, P.O. Box 2938, Minneapolis, MN 55402 (US).

(81) Designated States: CA, JP, European patent (AT, BE, CH, DE, DK, ES, FR, GB, GR, IE, IT, LU, MC, NL, PT, SE).

Published

With international search report.

(54) Title: COMPLEMENTARY FIELD-EFFECT TRANSISTOR LOGIC CIRCUITS FOR WAVE PIPELINING



(57) Abstract

A family of CFET logic circuits (100, 200, 202 and 360) useful for wave-pipeline systems is described, and a method to design same. The invention uses complementary transmission logic gates (221, 222; 121, 122; and 321, 322, 323, 324) and pull-up (224) or pull-down transistors to achieve a family of CFET logic circuits which include AND, NAND, OR, NOR, XOR, XNOR, select, select-invert, and not-invert functions. Each circuit (100, 200, 202 and 360) is tuned to provide substantially equal delays, high-quality ones and zeros, and substantially equal rise and fall times, for every combination of input-state transition and output-state transition.

BEST AVAILABLE COPY

FOR THE PURPOSES OF INFORMATION ONLY

Codes used to identify States party to the PCT on the front pages of pamphlets publishing international applications under the PCT.

AT	Austria	GB	United Kingdom	MR	Mauritania
AU	Australia	GE	Georgia	MW	Malawi
BB	Barbados	GN	Guinea	NE	Niger
BE	Belgium	GR	Greece	NL	Netherlands
BF	Burkina Faso	HU	Hungary	NO	Norway
BG	Bulgaria	IE	Ireland	NZ	New Zealand
BJ	Benin	IT	Italy	PL	Poland
BR	Brazil	JP	Japan	PT	Portugal
BY	Belarus	KE	Kenya	RO	Romania
CA	Canada	KG	Kyrgyzstan	RU	Russian Federation
CF	Central African Republic	KP	Democratic People's Republic of Korea	SD	Sudan
CG	Congo	KR	Republic of Korea	SE	Sweden
CH	Switzerland	KZ	Kazakhstan	SI	Slovenia
CI	Côte d'Ivoire	LI	Liechtenstein	SK	Slovakia
CM	Cameroon	LK	Sri Lanka	SN	Senegal
CN	China	LU	Luxembourg	TD	Chad
CS	Czechoslovakia	LV	Latvia	TG	Togo
CZ	Czech Republic	MC	Monaco	TJ	Tajikistan
DE	Germany	MD	Republic of Moldova	TT	Trinidad and Tobago
DK	Denmark	MG	Madagascar	UA	Ukraine
ES	Spain	ML	Mali	US	United States of America
FI	Finland	MN	Mongolia	UZ	Uzbekistan
FR	France			VN	Viet Nam
GA	Gabon				

COMPLEMENTARY FIELD-EFFECT TRANSISTOR LOGIC CIRCUITS FOR WAVE PIPELINING

5

Field of the Invention

The present invention relates to digital logic circuits and more specifically to Complementary Field-Effect Transistor logic circuits suitable
10 for wave pipelining.

Background of the Invention

Conventional Complementary Field-Effect Transistors ("CFET") logic circuits include N-channel field-effect transistors ("NFET") and P-channel field-effect transistors ("PFET"). In the following description the terms
15 CFET, NFET, and PFET should be interpreted to include all field-effect transistor integrated circuit technologies. Metal-Oxide Semiconductor ("MOS") processes are often used to fabricate Field-Effect Transistors ("FET") logic circuits. As used in this description, the terms MOS and FET are interchangeable.

20 Conventional logic-circuit-design techniques contemplate increasing the throughput of a system with a "pipeline". The pipeline comprises a number of logic sections, each separated by a register section. Each system clock transition allows a "data signal" (herein also simply called "signal") to propagate from one register section, through the following logic section, and
25 to the inputs of the following register section. Typically, new signal inputs are not fed into a logic section until the previous signal outputs are latched into the register section following that logic section. The maximum clock frequency for a logic section (i.e., the frequency with which new data can be switched into a logic section) is limited by the maximum propagation delay of
30 a path through that logic section.

One way of increasing system throughput is to break up logic sections into smaller sections (each with a shorter propagation delay) and insert pipeline register-section levels to separate the smaller logic sections. The clock speed can then be increased to take advantage of the shorter logic-
35 section delays.

This "pipelining" technique has been used to obtain significant speed-up of a computer system. Figure 1a illustrates conventional pipelining, showing the edges of signals propagating through small combinational-logic blocks. Conventionally, a combinational-logical-function unit is partitioned into several smaller combinational-logic blocks, and register stages are inserted between adjacent combinational-logic blocks as the synchronizers. However, the inserted register stages contribute to increased physical area and added clock-distribution requirements, resulting in a limitation on performance.

10 The increasing demand for high-speed, compact devices and systems, and the limitations of existing design methods, have prompted researchers to look for alternate techniques that can lead to high-performance digital systems. One such method is called "wave pipelining". Wave pipelining eliminates intermediate register stages in a pipeline system by using the internal capacitance of a combinational block for storage. Wave-pipelined systems do, however, have strict requirements on (a) the uniformity of path delays, (b) uniformity of output-signal rise and fall times, and (c) the independence of delay from the pattern of input signal transitions.

Figure 1b shows one embodiment of a wave-pipelining technique. In Figure 1b, the internal capacitances in the combinational logic act in effect as temporary storage elements. These dynamic storage elements take the place of static registers used in the conventional pipelining method shown in Figure 1a. Under the approach shown in Figure 1b, new data values are latched in before the previous data values propagate to the next set of registers. In this way, there are multiple coherent data "waves" within the combinational-logic block. Hence, the system clock is much faster than the propagation delay of the combinational-logic block between adjacent system-clocked-register stages.

30 The concept of wave pipelining (also called "maximum-rate pipelining") was first described by Cotten [Cotten:69] and Anderson, et al. [Anderson:67], and was applied in the design of IBM360/91 floating-point

execution unit in the 1960's. The significant advantages of wave pipelining are:

- (1) Achieving very high pipeline rates that approach the physical speed limit of the technology;
- 5 (2) Increasing pipeline rate without significant latency increase;
- (3) Minimizing clock loading and reducing clock-distribution problems; and
- (4) Using fewer registers and reducing the area overhead otherwise required by conventional pipelining.

10 To obtain a high operating speed, each path through a given functional block must have similar path delays. This requires symmetric rise and fall times (collectively called "transition" times) of output signals, and, for each component within the logical-functional block, delays that are independent of the input-signal transition patterns. Wave-pipelined systems are susceptible to
15 process and environmental variations which will cause propagation-delay-variation problems [Klass:93b].

Recently, with the demanding digital system speed and throughput requirements of various applications, wave-pipelining has received considerable attention from many research groups [Wong:93] [Fan:92]
20 [Klass:92] [Zhang:93]. In addition, Ekroot [Ekroot:87] developed a theory of wave pipelining and a linear program to insert delay elements to balance the circuit with the assumptions of fixed gate- and module delays.

Wong et al. [Wong:93] [Wong:91] continued their initial research and developed the algorithms to automatically equalize delays in bipolar
25 combinational logic circuits to achieve a high degree of wave pipelining. These authors have also reported the results of a 63-bit population counter using CML (Common-Mode Logic) bipolar technology, and discussed the limitations of using standard CMOS technology for wave pipelining.

Fan et al. [Fan:92], and Klass and Mulder [Klass:92] studied the use
30 and limitations of CMOS technology for wave pipelining. They designed wave-pipelined CLA (Carry Look-Ahead) adders and showed performance improvement over conventional methods.

Lam et al. [Lam:92] analyzed valid clocking in wave-pipelined circuits using Timed Boolean Functions.

Joy and Ciesieski [Joy:91] have proposed certain physical placement of components and specific routing algorithms for laying out wave-pipelined
5 circuits. Klass, Flynn and Goor reported the design of a fast CMOS wave-pipelined multiplier [Klass:93b] [Klass:93a].

The timing constraints of wave-pipelined circuits have been carefully studied and discussed by several research groups. In summary, for a wave-pipelined system using edge-triggered registers, the minimum clock-period
10 relation should be [Cotten:69] [Klass:92] [Wong:91]:

$$t_{cp} > \text{Max}\{(\Delta_p + (2 * \Delta C) + t_s + t_h + t_{rf}), (\Delta_x + \Delta C + t_{ms} + t_{rf})\} \quad \{\text{Equation 1}\}$$

where the variables are defined as

- t_{cp} is the valid clock period,
- Δ_p is the maximum time difference between the longest and shortest
15 paths for the worst-case design,
- ΔC is the worst-case clock skew,
- t_s is the setup time for registers,
- t_h is the hold time for registers,
- t_{rf} is the worst-case rise/fall time at the last logic stage,
- 20 Δ_x is the maximum time difference between the longest and shortest path from the global inputs to an internal signal node X, and
- t_{ms} is the minimum stable time for X to insure the correct operation of the next logic stage.

Both transition times and signal-propagation delays must be
25 constrained to avoid data wave interference. The clock period time limit to prevent interference of a data wave with any previous data wave at the ending storage element of a wave-pipelined logic section is bounded by $t_{cp} > (\Delta_p + (2 * \Delta C) + t_s + t_h + t_{rf})$. The clock period time limit to prevent interference of a data wave with any previous data wave inside a section of combinational
30 logic is bounded by $t_{cp} > (\Delta_x + \Delta C + t_{ms} + t_{rf})$.

To achieve maximum wave-pipeline rate, designers should minimize t_{cp} in Equation 1. Here, it is assumed that the clock skew ΔC can be minimized

by conventional design techniques, and that the terms t_s , t_h , t_f , and t_{ms} are technology-dependent parameters and specific to a certain logic stage, so they can be optimized individually. The remaining terms, Δt_p and Δt_x , arise from the following possible sources:

- 5 (1) path differences due to practical circuit configurations,
- (2) data-dependent signal-delay variations, and
- (3) process- and temperature-induced variations.

As some process- and temperature-induced variations are unavoidable, the focus should be on the path differences that are due to practical circuit
10 configurations and data-dependent delay variations. Therefore, if possible, a wave-pipelined circuit should be designed to have balanced paths (in terms of the basic logic gates and delay elements) in order to keep Δt_p and Δt_x as close to zero as possible.

Unfortunately, most practical digital circuits do not have such balanced
15 configurations. Therefore, specific algorithms have been suggested for designing practical wave-pipelined circuits by inserting delay elements ("rough tuning") and adjusting gate-driving abilities ("fine tuning") [Wong:93] [Wong:89].

Even for a balanced circuit, the data-dependent delay variations of
20 logic gates can still contribute to the values of Δt_p and Δt_x . This fact establishes that, from the viewpoint of circuit designers, the minimum clock period is eventually bounded by the delay variations of the basic logic circuit used in a wave-pipelined system. Therefore, the choice of the circuit family for the wave-pipelined system design can have a significant impact on
25 performance through the effect of delay variations at the gate level. A set of ideal properties of the basic circuits for wave pipelining can be summarized as follows:

- (1) same gate delay for both rising and falling edges of output signal,
- (2) no variation in the gate delay due to different input patterns, and
- 30 (3) no variation in the gate delay due to different previous input patterns.

By examining these requirements, it was found that bipolar circuit families (Emitter-Coupled Logic ("ECL"), super-buffered ECL, and Common-Mode Logic ("CML")) are good candidates for wave pipelining [Wong:93].

Standard CMOS was not well suited for this technique, since CMOS gate
5 delay depends strongly on the input patterns or different signal-timing patterns [Klass:92] [Fan:92]. For example, the standard prior-art two-input CMOS NAND gate 10 shown in Figure 1c has two transistors in parallel (21 and 22) and two transistors in series (23 and 24). The physical characteristics of transistors 23 and 24 can be designed so that together they pull output 31
10 down to a logic "zero" at a rate corresponding to the rate that transistors 21 and 22 together can pull output 31 up to a logic "one". In such an embodiment, if input signals 11 and 12 both start at "one", and both switch to "zero", transistor 21 and transistor 22 will both switch, driving output 31 from ground potential 14 to V_{DD} voltage 15. If, however, only a single input
15 switches to "zero" (e.g., input 11), only a single transistor (e.g., transistor 21) will pull output 31 to V_{DD} voltage 15. Since there is some capacitance associated with output 31, when both transistors 21 and 22 are pulling output 31, output 31 will switch faster than if either transistor 21 or 22 alone is driving output 31. Therefore, in CFET NAND gates, rise times vary as a
20 function of the input state transitions.

Since CMOS technology is a dominant and mature technology in the modern semiconductor industry, and has certain unique positive features for digital system design, it is necessary to attack the practical problems of unequal delays and asymmetric rise and fall times and to explore novel design
25 techniques that are suitable for CMOS wave pipelining. Researchers have studied the basic logic-circuit issues of CMOS wave-pipelining technique and have proposed some solutions. For instance, in [Fan:92] and [Gray:91], the basic logic circuits used are an inverter (not shown) and a two-input cross-coupled pseudo-NMOS NAND gate 40 (shown in Figure 1d), which is formed
30 by stacking cross-coupled n-channel transistors under a p-channel active pull-up device with bias voltage V_b . Since, however, the bias voltage V_b has to be distributed all over the wave-pipelined circuit chip, and the gate delay is

sensitive to the bias-voltage value, careful routing is needed to insure proper functioning of the circuit [Fan:92].

In an alternative approach, a balanced CMOS NAND gate (Figure 1e) is proposed in [Klass:92] to reduce the static CMOS gate-delay variations by adding a redundant ground-biased PMOS device to "soften" the input-pattern-dependent delay variation. This approach, however, has the drawbacks of increased layout area, loading capacitance, gate delays and dynamic power dissipation.

Klass [Klass:93a] describes a wave-pipelining circuit using standard CMOS logic gates. In [Klass:93b] and [Klass:93a], a conventional static CMOS NAND gate and an inverter were used as the basic circuits; however, the design was restricted to use 2-input NAND gates and invertors for every logic function, to minimize the delay sensitivity of the circuit to the input data patterns. In addition, every function block had to be verified separately to avoid large delay variations.

Each of the above approaches use only 2-input NAND gates and invertors as the basic circuits to implement arbitrary logic functions. This constraint can lead to a large chip area, and will limit the applications of wave pipelining.

Wong [Wong:93] presents an algorithm for designing a wave-pipelining circuit with minimal area and minimal power consumption. The algorithm involves: (1) rough tuning, by adding delay elements to balance circuit paths; and (2) fine tuning, by adjusting gate drives to compensate for delay variations introduced by different "fanouts" (the number of loads; in CFET technology this is primarily the sum of the capacitive load of each gate driven by the output driver, plus the capacitance of inter-circuit wiring).

Other FET logic families have also been explored. For instance, Complementary Pass-transistor Logic ("CPL") has proven to be a high-speed, area-efficient, and low-power technique [Yano:90] [Weste:93] [Shimohigashi:93]. Figure 1f shows an example of a basic prior-art CPL logic circuit 60 [Yano:90]. In the embodiment shown in Figure 1f, the same circuit is used to implement AND, NAND, OR, and NOR functions; the

function is determined by selection of the signals provided at the circuit inputs. The design method presented by Yano et al. [Yano:90] had no p-channel transistor in the pass network. Dual input signals and n-channel pass-transistors were used to implement dual-output gate circuits.

5 The circuit shown in Figure 1f does have drawbacks. Circuit 60 does not make efficient transitions with respect to logic-high input signals because of the poor "one" conduction problem of the NMOS pass-transistors (the maximum voltage for logic "one" is bounded by $V_{DD}-V_T$). So Yano et al. [Yano:90] utilized a specific fabrication technology, in which NMOS pass-transistors 62 were designed to have a zero threshold voltage $V_T=0$ volts, 10 whereas the other NMOS and PMOS transistors had a $V_T=\pm 0.4$ volts, respectively. With this design method, the quality of the logic-high is indeed improved, but noise immunity and reliability are reduced. In addition, the special fabrication requirements limit its wide application.

15 None of the above methods appear to teach how to design a family of field-effect-transistor-based circuits which provide substantially equal delays regardless of the pattern of the input logic-state transitions, and which provide a high-quality logic one as well as a high-quality logic zero.

Summary of the Invention

20 The present invention is a family of CFET logic circuits useful for wave-pipeline systems, and a method to design same. The invention uses complementary transmission gates and pull-up or pull-down transistors to achieve a family of CFET logic circuits which include AND, NAND, OR, NOR, XOR, XNOR, select, select-invert, invert, and not-invert functions..

25 Each circuit is tuned to provide substantially equal delays, high-quality logic ones and zeros, and substantially equal rise and fall times for every combination of input-state transition and output-state transition.

 According to one aspect of the present invention, a circuit is described which can be used for AND, NAND, OR, or NOR functions, depending on 30 the input connections. This circuit includes a first pass transistor having a first terminal coupled to a first input signal, a second terminal coupled to an internal node, and a gate coupled to a second input signal; a second pass

transistor having a first terminal coupled to the first input signal, a second terminal coupled to the internal node, and a gate coupled to a logical complement of the second input signal; a third transistor having a first terminal coupled to a voltage source, a second terminal coupled to the internal node, and a gate coupled to the second input signal; and a driver coupled to the internal node, the driver comprising means for amplifying a voltage, adjusting logic levels, and providing an output signal. If the voltage source coupled to the third transistor is a "one" level, the circuit can be used as an AND or NOR gate. If the voltage source coupled to the third transistor is a "zero" level, the circuit can be used as a NAND or OR gate. In one embodiment, the first transistor has a first channel type, the second transistor has a second channel type, and the third transistor also has the second channel type. In one such embodiment, the first channel type is N-channel, and the second channel type is P-channel. In another embodiment, the first channel type is P-channel, and the second channel type is N-channel.

According to another aspect of the present invention, a circuit is described which can be used for XOR, XNOR, select, or inverse-select functions. This circuit includes a first pass transistor having a first terminal coupled to a first input signal, a second terminal coupled to an internal node, and a gate coupled to a second input signal; a second pass transistor having a first terminal coupled to the first input signal, a second terminal coupled to the internal node, and a gate coupled to a logical complement of the second input signal; a third pass transistor having a first terminal coupled to a logical complement of the first input signal, a second terminal coupled to the internal node, and a gate coupled to a logical complement of the second input signal; a fourth pass transistor having a first terminal coupled to a logical complement of the first input signal, a second terminal coupled to the internal node, and a gate coupled to the second input signal; and a driver coupled to the internal node, comprising means for amplifying a voltage, adjusting logic levels, and providing an output signal. In one embodiment, the first and third transistors have a first channel type, and the second and fourth transistor have a second channel type. In one such embodiment, the first channel type is N-

channel, and the second channel type is P-channel. In another embodiment, the first channel type is P-channel, and the second channel type is N-channel.

According to yet another aspect of the present invention, a circuit is described which can be used for generating dual-rail signals from single-rail signals, or for inverting or non-inverting delay buffers. This circuit includes a first pass transistor having a first terminal coupled to a first input signal, a second terminal coupled to an internal node, and a gate coupled to a first voltage source; a second pass transistor having a first terminal coupled to the first input signal, a second terminal coupled to the internal node, and a gate coupled to a second voltage source; and a driver coupled to the internal node, the driver comprising means for amplifying a voltage, adjusting logic levels, and providing an output signal.

According to yet another aspect of the present invention, a method is described for designing a CFET logic circuit having a uniform overall gate delay. The method comprises the steps: forming a Karnaugh map of the desired function; assigning each cell in the Karnaugh map to a pair of adjacent cells; implementing a transmission gate for each pair of adjacent Karnaugh-map cells having one high value and one low value; implementing a pull-up transistor for each pair of adjacent Karnaugh-map cells having two high values; implementing a pull-down transistor for each pair of adjacent Karnaugh-map cells having two low values; and adjusting the sizes and/or speeds of the pull-up transistor, the pull-down transistor, and the transmission gate to make the overall gate delay and the transition times of the output signal substantially independent of input transition pattern.

According to yet another aspect of the present invention, a method is described for designing a CFET logic gate-pair circuit having a delay substantially independent of input transition pattern, where the circuit has a first pull transistor, a second pull transistor having a channel type complementary to the channel type of the first pull transistor, and a first transmission gate comprising an NFET and a PFET. The method comprises the steps: providing a size for the first pull transistor; determining a size for the second pull transistor in order to ensure substantially equal rise and fall

times of the first and second pull transistors; determining a ratio of NFET size to PFET size of the first transmission gate to ensure substantially equal rise and fall times of the transmission gate; and determining a ratio of the first transmission gate size to the first pull transistor size to ensure substantially
5 equal transition times and substantially equal gate propagation delays.

According to yet another aspect of the present invention, a complementary field-effect transistor logic circuit is described comprising a first pass transistor having a first channel type and having a first terminal coupled to a first input signal, a second terminal coupled to an internal node,
10 and a gate coupled to a second input signal; a second pass transistor having a second channel type which is complementary to the first channel type and having a first terminal coupled to the first input signal, a second terminal coupled to the internal node, and a gate coupled to a logical complement of the second input signal; a third transistor having the second channel type and
15 having a first terminal coupled to a voltage terminal, a second terminal coupled to the internal node, and a gate coupled to the second input signal; and a driver coupled to the internal node, comprising means for amplifying a voltage and adjusting logic levels at an output signal.

According to yet another aspect of the present invention, a
20 complementary field-effect transistor logic circuit is described comprising a first transistor for coupling a first input signal to an output signal in response to a second input signal; a second transistor for coupling the first input signal to the output signal in response to a logical complement of the second input signal; and a third transistor for coupling a logical-high signal to the output
25 signal in response to the second input signal; wherein parameters of the first, second, and third transistors are chosen such that propagation delays for any combination of logical value transitions are substantially equal.

According to yet another aspect of the present invention, a complementary field-effect transistor parallel-adder logic circuit is described
30 comprising a plurality of pg generator circuits wherein each pg generator circuit comprises an AND/NAND gate circuit and a XOR/XNOR gate circuit; a plurality of black processor circuits wherein at least two of the black

processor circuits are coupled to outputs of the pg generator circuits and wherein each black processor circuit comprises a MUX/inverse-MUX gate circuit and an AND/NAND gate circuit; and a plurality exclusive-OR circuits coupled to at least two outputs of the black processor circuits.

5 According to yet another aspect of the present invention, a complementary field-effect transistor 4:2 compressor logic circuit is described comprising a first OR/NOR gate coupled to a first input signal and a second input signal and producing a first internal OR/NOR signal; a second OR/NOR gate coupled to a third input signal and a fourth input signal and producing a
10 second internal OR/NOR signal; a first AND/NAND gate coupled to the first internal OR/NOR signal and the second internal OR/NOR signal and producing a carry-out signal; a second AND/NAND gate coupled to the first input signal and the second input signal and producing a first internal AND/NAND signal; a third AND/NAND gate coupled to the third input signal and the fourth input
15 signal and producing a second internal AND/NAND signal; a third OR/NOR gate coupled to the first internal AND/NAND signal and the second internal AND/NAND signal and producing a third internal OR/NOR signal; a first XOR/XNOR gate coupled to the first input signal and the second input signal and producing a first internal XOR/XNOR signal; a second XOR/XNOR gate
20 coupled to the third input signal and the fourth input signal and producing a second internal XOR/XNOR signal; a third XOR/XNOR gate coupled to the first internal XOR/XNOR signal and the second internal XOR/XNOR signal and producing a third internal XOR/XNOR signal; a fourth XOR/XNOR gate coupled to the third internal XOR/XNOR signal and a carry-in signal and
25 producing an S signal; and a MUX/inverse-MUX gate coupled to the third internal XOR/XNOR signal and the carry-in signal and the third internal OR/NOR signal and producing a C signal.

Brief Description of the Drawings

Figure 1a is a schematic diagram illustrating a regular pipelining
30 technique;

Figure 1b is a schematic diagram illustrating a wave-pipelining technique;

Figure 1c is a schematic diagram illustrating a prior-art CMOS NAND gate;

Figure 1d is a schematic diagram illustrating a prior-art cross-coupled pseudo-NMOS NAND gate;

5 Figure 1e is a schematic diagram illustrating a prior-art balanced-CMOS NAND gate;

Figure 1f is a schematic diagram illustrating a prior-art Complementary Pass-transistor Logic (CPL) AND/NAND/OR/NOR gate;

10 Figure 2a is a schematic flow diagram illustrating a method for designing a gate circuit from an inverse Karnaugh map according to the invention;

Figure 2b is a schematic diagram illustrating an embodiment of a CFET logic circuit according to the invention having an output which has one high-level output state;

15 Figure 2c is a schematic flow diagram illustrating a method for designing another gate circuit from an inverse Karnaugh map according to the invention;

Figure 2d is a schematic diagram illustrating an embodiment of a CFET logic circuit according to the invention having an output which has
20 three high-level output states;

Figure 2e is a schematic diagram illustrating an embodiment of a CFET logic circuit according to the invention providing an inverting buffer;

Figure 2f is a schematic diagram illustrating an embodiment of a pair of CFET logic circuits as shown in Figures 2b and 2d connected to provide an
25 AND/NAND function;

Figure 2g is a schematic diagram illustrating an embodiment of a pair of CFET logic circuits as shown in Figures 2b and 2d connected to provide an OR/NOR function;

Figure 3a is a schematic diagram illustrating an embodiment of a
30 CFET logic circuit according to the invention having an output which has two high-level output states;

Figure 3b is a schematic diagram illustrating an embodiment of a CFET logic circuit as shown in Figure 3a connected to provide an XOR function;

Figure 3c is a schematic diagram illustrating an embodiment of a CFET logic circuit as shown in Figure 3a connected to provide an XNOR function;

Figure 3d is a schematic diagram illustrating an embodiment of a CFET logic circuit as shown in Figure 3a connected to provide a 2-input multiplexor function;

Figure 3e is a schematic diagram illustrating an embodiment of a CFET logic circuit as shown in Figure 3a connected to provide an inverse 2-input multiplexor function;

Figure 4a is a schematic diagram illustrating an embodiment of a CFET logic circuit according to the invention having an inverting output state;

Figure 4b is a schematic diagram illustrating an embodiment of a CFET logic circuit according to the invention having a non-inverting output state;

Figure 5a is a schematic diagram showing an equivalent circuit for the 11->00 and 11->10 input state transitions of the circuit in Figure 2b;

Figure 5b is a schematic diagram showing an equivalent circuit for the 11->00 and 11->10 input state transitions of the circuit in Figure 2d;

Figure 5c is a schematic diagram showing an equivalent circuit for the 11->01 input state transition of the circuit in Figure 2b;

Figure 5d is a schematic diagram showing an equivalent circuit for the 11->01 input state transition of the circuit in Figure 2d;

Figure 5e is a schematic diagram showing an equivalent circuit for the 01->11 input state transition of the circuit in Figure 2b;

Figure 5f is a schematic diagram showing an equivalent circuit for the 01->11 input state transition of the circuit in Figure 2d;

Figure 5g is a schematic diagram showing an equivalent circuit for the 10->11 input state transition of the circuit in Figure 2b;

Figure 5h is a schematic diagram showing an equivalent circuit for the 10->11 input state transition of the circuit in Figure 2d;

Figure 5i is a schematic diagram showing an equivalent circuit for the 00->11 input state transition of the circuit in Figure 2b;

5 Figure 5j is a schematic diagram showing an equivalent circuit for the 00->11 input state transition of the circuit in Figure 2d;

Figure 6 is a schematic diagram showing a 16-bit carry look-ahead adder implemented with WTGL gates; and

10 Figure 7 is a schematic diagram showing a 4:2 compressor circuit implemented with WTGL gates.

Description of the Preferred Embodiment

In the following detailed description of the preferred embodiments, reference is made to the accompanying drawings which form a part hereof, and in which are shown by way of illustration specific embodiments in which 15 the invention may be practiced. It is to be understood that other embodiments may be utilized and structural changes may be made without departing from the scope of the present invention.

Improved Complementary Pass-transistor Logic (CPL) circuits can be used as the basic cells to implement a high-performance CFET wave-pipelined 20 system. This family of basic cells, called "Wave-pipelined Transmission-Gate Logic" ("WTGL"), can be designed to have substantially equal signal rise and fall times and reduced gate-delay variations. Each circuit uses a configuration of transmission gates, pull-up/pull-down transistors, and dual-rail input signals to perform a basic logic function; each circuit also has an inverter-driver to 25 drive the next logic stage. In one embodiment, the inverter-driver is fabricated in CMOS, as shown in Figure 2e.

A Karnaugh map can be used to design the basic WTGL cell. The procedure for designing a two-input AND gate is shown in Figures 2a and 2b. Please note that in these embodiments, since each basic cell is buffered by an 30 inverter, the Karnaugh maps are shown for the logical complements of the desired functions. For instance, in Figure 2a, Karnaugh map 201 shows the map for the inverse of a two-input AND gate, which has three high states and

one low state. According to Karnaugh map 201, a pass network 200 with inputs of A, B, and "one" could be used to provide the function shown in Figure 2a, with driver-invertor circuit 232 providing the proper-polarity AND function.

5 Figure 2b shows one embodiment of a pass network 200 which can be used to implement the AND function of Figure 2a. Although the embodiment shown in Figure 2b uses CMOS transistors, persons skilled in the art will readily understand that any complementary field-effect transistor technology could be used to advantage. In the embodiment shown in Figure 2b, a CMOS
10 transmission gate (transistors 221 and 222) and a pull-up transistor 224 have replaced the NMOS pass-transistor of the CPL designs shown in Figure 1f. Thus, the quality of logic "one" is guaranteed at the gates of output invertors even using standard CMOS technology.

 In this embodiment, n-channel pass transistor 221 and p-channel pass
15 transistor 222 form a CFET transmission gate. (In this configuration, it is not particularly meaningful to distinguish transistor terminals as drain or source, since the relative voltage between input 211 and node 231 may be either positive or negative, depending on the states of inputs 211, 212, and 213. The physical layout is generally symmetric for the source, gate, and drain
20 terminals. Therefore, rather than using the terms "source" and "drain", these drain/source transistor connections will each be called "terminals".) Input 211 is coupled to one terminal of n-channel pass transistor 221, input 213 is coupled to the gate of n-channel pass transistor 221, and the other terminal of n-channel pass transistor 221 is connected to node 231. Input 211 is also
25 coupled to one terminal of p-channel pass transistor 222, input 212 is coupled to the gate of p-channel pass transistor 222, and the other terminal of p-channel pass transistor 222 is connected to node 231. In this embodiment, the substrates of the p-channel devices are internally connected to V_{DD} (voltage 215 in this embodiment), and the substrates of the n-channel devices are
30 internally connected to V_{SS} (the ground voltage 216 in this embodiment).

 The circuit of Figure 2b can be used to implement the AND function of Figure 2a. To do so, input 213 is connected to logic signal B of Figure 2a,

input 211 is connected to \bar{A} of Figure 2a, and input 212 is connected to \bar{B} of Figure 2a. The transmission gate formed by transistors 221 and 222 passes \bar{A} from input 211 to node 231 if B is high, and is cutoff if B is low. V_{DD} voltage 215 is coupled to one terminal of p-channel pull-up transistor 224, input 213 is coupled to the gate of p-channel pull-up transistor 224, and the other terminal of p-channel pull-up transistor 224 is connected to node 231. Pull-up transistor 224 passes a "one" from V_{DD} voltage 215 to node 231 if B is low, and is cutoff if B is high. Thus, Karnaugh map 201 represents the state of node 231; inverter driver 232 then amplifies this voltage and inverts it (adjusting the logic level from negative to positive), thus providing the proper polarity AND function at output 233.

Figures 2c and 2d show the corresponding procedure for designing a two-input NAND gate. In Figure 2c, Karnaugh map 101 shows the map for the *inverse* of a two-input NAND gate, which has three low states and one high state. According to the Karnaugh map 101, a pass network 100 having inputs of A, B, and "zero" could be used to provide the function shown in Figure 2c.

Figure 2d shows one embodiment of a pass network 100 which can be used to implement the NAND function of Figure 2c. In this embodiment, n-channel pass transistor 121 and p-channel pass transistor 122 form a CFET transmission gate. Input 111 is coupled to one terminal of n-channel pass transistor 121, input 113 is coupled to the gate of n-channel pass transistor 121, and the other terminal of n-channel pass transistor 121 is connected to node 131. Input 111 is also coupled to one terminal of p-channel pass transistor 122, input 112 is coupled to the gate of p-channel pass transistor 122, and the other terminal of p-channel pass transistor 122 is connected to node 131.

The circuit of Figure 2d can be used to implement the NAND function of Figure 2c. To do so, input 113 is connected to B of Figure 2c, input 111 is connected to A of Figure 2c, and input 112 is connected to \bar{B} of Figure 2c. The transmission gate formed by transistors 121 and 122 passes A from input 111 to node 131 if B is high, and is cutoff if B is low. Ground voltage 114 is

coupled to one terminal of n-channel pull-down transistor 123, input 112 is coupled to the gate of n-channel pull-down transistor 123, and the other terminal of n-channel pull-down transistor 123 is connected to node 131.

Pull-down transistor 123 passes a "zero" from ground voltage 114 to node 131

- 5 if B is high, and is cutoff if B is low. Thus, Karnaugh map 101 represents the state of node 131; inverter driver 132 then amplifies this voltage and inverts it (adjusting the logic level from negative to positive), thus providing the proper polarity NAND function at output 133.

Figure 2f is a schematic diagram illustrating an embodiment of a pair
10 of CFET logic circuits as shown in Figures 2b and 2d connected to provide an AND/NAND function. Paired circuit 202 produces AB and, at the same time and with the same delay, \overline{AB} . This circuit can also be used to implement an OR/NOR function (e.g., A to input 211, \overline{B} to input 213, and B to input 212 provides the NOR function, $\text{NOT}(A+B)$, at output 233; \overline{A} to input 111, \overline{B} to
15 input 113, and B to input 112 provides the OR function $A+B$ at output 133). Figure 2g is a schematic diagram illustrating an embodiment of a pair of CFET logic circuits as shown in Figures 2b and 2d connected as a paired circuit 202 to provide an OR/NOR function.

Figure 3a is a schematic diagram illustrating an embodiment of a
20 CFET logic circuit according to the invention having an output which has two high-level output states. This circuit is used to implement the exclusive-OR ("XOR") function or the inverse-XOR function. In addition, this circuit is used to provide the multiplexor ("MUX") function and the inverse-MUX function. In the embodiment shown in Figure 3, n-channel pass transistor 321
25 and p-channel pass transistor 322 form one CFET transmission gate; n-channel pass transistor 323 and p-channel pass transistor 324 form another CFET transmission gate. Input 311 is coupled to one terminal of n-channel pass transistor 321, input 313 is coupled to the gate of n-channel pass transistor 321, and the other terminal of n-channel pass transistor 321 is connected to
30 node 331. Input 311 is also coupled to one terminal of p-channel pass transistor 322, input 314 is coupled to the gate of p-channel pass transistor 322, and the other terminal of p-channel pass transistor 322 is connected to

node 331. Input 312 is coupled to one terminal of n-channel pass transistor 323, input 315 is coupled to the gate of n-channel pass transistor 323, and the other terminal of n-channel pass transistor 323 is connected to node 331.

- Input 312 is also coupled to one terminal of p-channel pass transistor 324,
 5 input 316 is coupled to the gate of p-channel pass transistor 324, and the other terminal of p-channel pass transistor 324 is connected to node 331.

Figure 3b is a schematic diagram illustrating an embodiment of a CFET logic circuit as shown in Figure 3a connected to provide an XOR function. In this embodiment, inputs 313 and 316 are connected to B, input
 10 311 is connected to A, inputs 314 and 315 are connected to \bar{B} , and input 312 is connected to \bar{A} . The transmission gate formed by transistors 321 and 322 passes A from input 311 to node 331 if B is high, and is cutoff if B is low. The transmission gate formed by transistors 323 and 324 passes \bar{A} from input
 15 312 to node 331 if B is low, and is cutoff if B is high. Thus, $(\bar{A}\bar{B} + AB)$ represents the state of node 331; inverter driver 332 then amplifies this voltage and inverts it (adjusting the logic level from negative to positive), thus providing the proper polarity XOR function $(A\bar{B} + \bar{A}B)$ at output 333.

Another embodiment, shown in Figure 3c, uses a CFET logic circuit as shown in Figure 3a connected to provide the inverse-exclusive-OR ("XNOR")
 20 function. Inputs 313 and 316 are connected to B, input 311 is connected to \bar{A} , inputs 314 and 315 are connected to \bar{B} , and input 312 is connected to A. The transmission gate formed by transistors 321 and 322 passes \bar{A} from input 311 to node 331 if B is low, and is cutoff if B is high. The transmission gate formed by transistors 323 and 324 passes A from input 312 to node 331 if B
 25 is high, and is cutoff if B is low. Thus, $(A\bar{B} + \bar{A}B)$ represents the state of node 331; inverter driver 332 then amplifies this voltage and inverts it (adjusting the logic level from negative to positive), thus providing the proper polarity XNOR function $(\bar{A}\bar{B} + AB)$ at output 333.

Yet another embodiment, shown in Figure 3d, uses a CFET logic
 30 circuit as shown in Figure 3a connected to provide a 2-input multiplexor ("MUX") function. Inputs 313 and 316 are connected to \bar{C} , input 311 is connected to \bar{A} , inputs 314 and 315 are connected to C, and input 312 is

connected to \bar{B} . Thus, $\text{NOT}(AC + B\bar{C})$ represents the state of node 331; inverter driver 332 then amplifies this voltage and inverts it, providing the proper-polarity MUX function $(AC + B\bar{C})$ at output 333.

Yet another embodiment, shown in Figure 3e, uses a CFET logic circuit as shown in Figure 3a connected to provide a inverse 2-input multiplexor ("inverse-MUX") function. Inputs 313 and 316 are connected to C, input 311 is connected to A, inputs 314 and 315 are connected to \bar{C} , and input 312 is connected to B. Thus, $(AC + B\bar{C})$ represents the state of node 331; inverter driver 332 then amplifies this voltage and inverts it, providing the proper-polarity inverse-MUX function $\text{NOT}(AC + B\bar{C})$ at output 333.

Even when a logic function is not required, it is critical to maintain corresponding logic delays through each wave-pipeline section. To do this, the WTGL family of circuits includes a non-inverting and inverting logic circuits. Figure 4a is a schematic diagram illustrating an embodiment of a CFET logic circuit according to the invention having an inverting output state. Transmission gate 420 formed by transistors 421 and 422 always passes signal A from input 411 to node 431. Inverter 432 inverts this signal and provides \bar{A} at output 433 with the same delay characteristics as the other above-described circuits of the invention. Because the transmission gate circuit is similar to those of Figures 2b, 2d, and 3, the delay characteristics can be adjusted to match those of the logic gates.

Figure 4b is a schematic diagram illustrating an embodiment of a CFET logic circuit according to the invention having a non-inverting output state. Inverter 434 is designed to match the delay characteristics of a transmission gate such as transmission gate 420 of FIG 4a. If input 412 is coupled to signal A, then node 435 will represent \bar{A} . Inverter 436 then re-inverts the signal at node 435 and provides signal A at output 437 with the same delay characteristics as the other above-described circuits of the invention.

In order to implement a high-speed wave-pipelined system, the basic cells must have good delay properties, and must be as insensitive to the input signal transition patterns as possible. Therefore, the delay characteristics of

WTGL gate circuits must be critically analyzed to evaluate the feasibility of each circuit for wave-pipelining design.

The actual delay properties of the WTGL circuits in Figures 2b and 2d depend strongly on device sizing. This gate delay can be evaluated and
5 compared by, for instance, observing the charging and discharging of internal nodes 231 and 131.

Any of numerous methods well known to persons skilled in the art can be used to choose or adjust the parameters which affect the speeds of the various transistors to achieve overall gate delay balance, including but not
10 limited to: adjusting the width-to-length ratio of the transistor gate of a field-effect transistor, adjusting the thickness of a gate insulator, adjusting the carrier or impurity density, choosing the semiconductor material (e.g., silicon or gallium-arsenide) and doping material (e.g., phosphorus or arsenic), and changing the capacitances associated with the various terminals of the
15 transistor.

The circuit in Figure 2b has two alternatively-conducting paths to node 231: one is pull-up transistor 224, the other is the transmission gate (TG) formed by pass transistor 221 and pass transistor 222. Similarly, the circuit in Figure 2d has two alternatively-conducting paths to node 131: one is pull-
20 down transistor 123, the other is the transmission gate formed by pass transistor 121 and pass transistor 122. So with careful layout design of the basic circuit, it is possible to minimize the delay variations for all the input-pattern combinations by balancing the sizes of pull-up and pull-down transistors and the transmission gates. After detailed analysis of all the input-
25 pattern combinations, four cases of 231 (or 131) node charging and discharging equivalent circuits were obtained, as shown in Figures 5a through 5j. The dashed invertors at the inputs are the output driver-invertors of the previous stage. Dashed capacitors 239 and 139 are the equivalent lumped capacitances of the internal wiring and input gates of inverter-drivers 232 and
30 132 respectively.

Figure 5a is a schematic diagram showing an equivalent circuit for the 11->00 and 11->10 input state transitions of the circuit in Figure 2b. Figure

5b is a schematic diagram showing an equivalent circuit for the 11->00 and 11->10 input state transitions of the circuit in Figure 2d. Figure 5c is a schematic diagram showing an equivalent circuit for the 11->01 input state transition of the circuit in Figure 2b. Figure 5d is a schematic diagram showing an equivalent circuit for the 11->01 input state transition of the circuit in Figure 2d. Figure 5e is a schematic diagram showing an equivalent circuit for the 01->11 input state transition of the circuit in Figure 2b. Figure 5f is a schematic diagram showing an equivalent circuit for the 01->11 input state transition of the circuit in Figure 2d. Figure 5g is a schematic diagram showing an equivalent circuit for the 10->11 input state transition of the circuit in Figure 2b. Figure 5h is a schematic diagram showing an equivalent circuit for the 10->11 input state transition of the circuit in Figure 2d. Figure 5i is a schematic diagram showing an equivalent circuit for the 00->11 input state transition of the circuit in Figure 2b. Figure 5j is a schematic diagram showing an equivalent circuit for the 00->11 input state transition of the circuit in Figure 2d.

The goals in all the cases shown in Figures 5a through 5j are to balance the rise and fall times to each other for each output signal; once balanced, these are collectively called the "transition" time for the circuit. Then, the transition time for each circuit is balanced to equal the transition times of all the other circuits, to the greatest extent possible. Similarly, the propagation delay of each circuit must also be made substantially equal to the propagation delays of all the other circuits, to the greatest extent possible. The optimization method is given according to the actual switching behaviors of the circuit:

- (a) Pull-down NMOS sizing,
 - (b) Pull-up PMOS sizing,
 - (c) Transmission Gate rise and fall time balancing, and
 - (d) Overall delay balancing.
- First, a reference delay is determined for a basic-size pull-down NFET device; thus, a size is chosen for transistor 123 of Figure 5b, and a simulation of the equivalent circuit of Figure 5b is run to determine the delay and rise

time of that circuit, which is then used as a reference delay. Then, a simulation of Figure 5a is run and the size of the pull-up PFET device, transistor 224, is determined to ensure the rise time for the pull-up transistor of Figure 5a equals the fall time for the pull-down transistor in Figure 5b.

- 5 For Figures 5c, 5d, 5e, 5f, 5g, 5h, 5i, and 5j, the transmission gates are conducting to charge or discharge the 231 and 131 nodes. The optimized ratio of PFET to NFET size is determined in order to get substantially equal rise and fall times for the transmission gates; the size ratio of transistor 221 to transistor 222 will generally be the same as the size ratio of transistor 121 to transistor 122. Then, the whole transmission-gate size is adjusted to balance its delay with that of the appropriate pull-up or pull-down device. Since the parasitic effects are dependent on device size and layout style, the optimization procedure may need several iterations to achieve overall gate delay balance.

- 15 In one embodiment, simulations are done using a simulator like SPICE3, with the circuit netlist file extracted from physical layout (developed using MAGIC) whenever the circuit layout changes. With careful circuit analysis and intensive simulations of various device sizing, cells with the required properties can be developed.

- 20 By performing these steps, the overall delay variations of the WTGL AND/OR gate (with output loading ranging from 0 to 1pF) are considerably reduced compared to conventional static CFET technology. Similar balancing techniques can be used to minimize overall delay variations for the other circuits of the WTGL family. The result is a set of WTGL basic circuits, each with substantially similar delay and rise/fall times and each having dual-rail outputs, as follows:

- 25 (a) a 2-input AND / OR / NAND / NOR circuit (e.g., Figures 2f and 2g),
(b) a 2-input XOR / XNOR circuit (e.g., Figures 3b and 3c),
30 (c) a 2-to-1 MUX circuit (e.g., Figures 3e and 3f), and
(d) an inverter / non-inverter delay circuit for the interface between single-rail and dual-rail circuits and for inverting or non-inverting types of

delay element used as the padding elements (which are adjustable in terms of delay) (e.g., Figures 4a and 4b).

As noted above, the circuits for AND/NAND and OR/NOR functions are actually the same, the only difference being the coupling of input signals. A similar convention is applicable for XOR/XNOR and MUX/inverse-MUX functions. For the XOR/XNOR and MUX in Figures 3b, 3c, 3d, and 3e, the simulation of equivalent circuits 5c through 5j include all the possible charging and discharging cases with different input-pattern combinations. So the optimization procedure is simpler than that of the AND/OR/NAND/NOR gate described above for Figures 2f and 2g. Most importantly, all the basic logic circuits have the same delay properties. Hence, in contrast to the mere single logic circuit used in other approaches, the present invention provides a family of basic logic circuits which can be used to implement wave-pipelined systems (as shown in Figures 2e, 2f, 2g, 3b, 3c, 3d, 3e, 4a, and 4b) and which can be designed to all have substantially the same timing properties.

The dual-rail approach also has certain advantages over other techniques for wave-pipelined design. For instance, in single-rail systems, if the inputs of one logic level require both non-inverted and inverted terms (which is the most common case), and if only NANDs and invertors are available, then one has to insert both an invertor and a delay element to get substantially equally-delayed dual signals. Also, all the other signals at the same logic stage should be delayed by the same amount to keep the timing balance. Such adjustments result in an increase in system delay and layout area. In contrast, the WTGL basic circuit family can generate dual signal outputs simultaneously and the overall timing variation will still be maintained at the same low level.

Every wave-pipelined circuit must have substantially equal delay (balanced) paths under nominal fabrication conditions. Usually tuning is necessary to handle the unbalanced paths and various interconnections of practical circuits. The overall tuning procedure has two steps:

(1) rough tuning, to insert additional delay elements to make all the paths roughly in balance, and

(2) fine tuning, to deal with the specific driving requirements of various signal connections, as well as to achieve minimization of power requirements.

For the WTGL circuits, each output signal has a driving inverter which
5 can be fine-tuned separately to balance the delay variations induced by the different fanouts in a practical wave-pipelined circuit.

Recently, a Complementary Pass-transistor Logic (CPL) technique has been used by others to implement a wave-pipelined 8x8 multiplier fabricated in a normal CMOS process. Since the ideal maximum voltage swing at the
10 output of an NMOS pass block is only from 0 to $(V_{DD}-V_{TN})$, the logic threshold voltage of the output inverter must be set accordingly to achieve full output logic swing. Therefore, during the fine-tuning stage, judicious sizing of the entire cell (both the output inverters and the NMOS pass transistors) was needed to adjust the driving ability of the basic circuit. In contrast, with
15 the WTGL basic cells of the invention, the output inverters can be treated as single devices for fine tuning. A WTGL system has high regularity; all the internal signal nodes have, at most, one transistor and one transmission gate connected in series to V_{DD} or ground. Every stage has gate delays of the same magnitude (approximately equivalent to $Td_{inverter} + Td_{TG}$) and each output
20 signal has a separately-adjustable inverter. All of these characteristics are beneficial for practical CAD (Computer-Aided Design) tools development and logic synthesis.

Practical Circuit Design and Comparisons

25 In order to evaluate and verify the WTGL approach of the invention, several practical circuits have been designed. Since no CAD tools for CMOS wave-pipelined circuit design have been reported, the rough tuning and fine tuning were performed manually.

The results show that for the WTGL technique, since a family of basic
30 circuit cells having the same magnitude of gate delays and reduced delay variations is available, higher speed and more compact practical wave-pipelined circuits can be implemented than can be implemented with other

approaches which use only one basic cell (a NAND gate). In addition, the actual circuit-design experience confirms that the high structural regularity and dual-rail signal property of WTGL technique are well suited for wave-pipelined circuit design.

5

Parallel Carry-Look-Ahead Adder

One of the practical circuits designed was a 16-bit parallel adder. During the adder design, a parallel architecture was adopted. The circuit was modified to take advantage of the special dual-rail characteristics and flexible logic functional choices of WTGL.

10

The traditional propagation bit p_i and generation bit g_i of the i .th bit are:

$$(g_i, p_i) = (a_i b_i, a_i \text{ XOR } b_i) \quad \{\text{EQ. 2}\}$$

$$c_i = G_i \quad \text{for } i = 1, 2, \dots, n$$

15 The G_i is defined by an associate operator \circ introduced as follows:

$$(G_i, P_i) = (g_i, p_i) \quad \text{for } i = 1, \text{ and}$$

$$(G_i, P_i) = (g_i, p_i) \circ (G_{i-1}, P_{i-1}) = (g_i + p_i G_{i-1}, p_i P_{i-1}) \quad \text{for } i \neq 1 \quad \{\text{EQ. 3}\}$$

After the carry bit c_{i-1} is computed, the sum bit s_i is obtained by

$$s_i = p_i \text{ XOR } c_{i-1} \quad \text{and} \quad s_i = p_i$$

20 The logic-circuit block to implement the associate operation defined by equation EQ. 3 is called a Black Processor. If only 2-input NAND gates are available for wave-pipelined circuit design, both the associate operator \circ and the XOR need two logic stages to be implemented. But if equation EQ. 3 is analyzed while considering equation EQ. 2, one obtains:

$$25 \quad (g_i, p_i) \circ (G_{i-1}, P_{i-1}) = (\bar{p}_i g_i + p_i G_{i-1}, p_i P_{i-1}) \quad \text{for } i > 1.$$

The logic function of G_i becomes a single 2-to-1 MUX. Such a logic function is available in the WTGL basic-cell library (e.g., in Figure 3d) and it has the same gate delays as the XOR and AND/OR gates. Therefore, the Black Processor has exactly one logic stage for both G_i and P_i , and thus the total number of logic stages is significantly reduced. The new wave-pipelined adder architecture is shown in Figure 6. The logic functions of pg generators

30

are described in Equation EQ. 2. The Black Processors produce G_i and P_i , as indicated in Equation EQ. 3. In addition, the initial p_i s also need to be latched to the sum stage, along with the carries (the delay latches for p_i s are not explicitly shown in Figure 6). Since different driving ability is required
5 for some cells, the delay properties of the WTGL cells with different fanouts were simulated, and then the output inverter sizings were fine tuned to balance the delay variations among the inputs of every next-stage cell. Since the adder has a regular architecture, the fine tuning can be easily handled.

Some typical wave-pipelined addition operation sequences were
10 simulated by RSIM. It was found that average delay variation for SUM (the addition result vector) is about 0.9 ns (with SCMOS technology parameters). The delay variations are mainly due to the lack of more accurate and effective CAD tools for fine-tuning and to the intrinsic slight delay variations of the basic circuit cells. The new data waves are latched every 3 ns, so the data-
15 processing speed is 333 million operations per second.

It seems that for dual-rail wave-pipelined circuit design technique, the chip area and number of transistors would increase compared to other single-rail techniques. But the actual layout of the WTGL 16-bit adder is very compact, and the chip size and transistor counts observed using WTGL
20 methods are substantially smaller than those achieved using other methods. (This is because in the methods used by those other researchers, there is only one basic logic circuit -- a NAND gate -- available.)

Another practical circuit is a macro-cell, the 4:2 compressor, which is the basic building block of a multiplier. Figure 7 is a schematic circuit
25 diagram of an embodiment of a dual-rail WTGL 4:2 compressor design according to the invention. This WTGL approach takes about 120 transistors, but has a delay of only $3T_{d_{TG}} + 3T_{d_{INV}}$. In Figure 7, OR/NOR gates 71A, 71B, and 71C each comprise a pair of gate circuits: one of the type shown in Figure 2b wired (as described above) to provide one of the rail polarities, and
30 one of the type shown in Figure 2d wired to provide the other rail polarity. AND/NAND gates 72A, 72B, and 72C also each comprise a pair of gate circuits: one of the type shown in Figure 2b to provide one of the rail

polarities, and one of the type shown in Figure 2d to provide the other rail polarity. XOR/XNOR gates 73A, 73B, 73C, and 73D each comprise a pair of gate circuits: one of the type shown in Figure 3a wired to provide one of the rail polarities as in Figure 3b, and another also of the type shown in

5 Figure 3a, but wired to provide the other rail polarity as in Figure 3c.

MUX/inverse-MUX gate 74 comprises a pair of gate circuits: one of the type shown in Figure 3a wired to provide one of the rail polarities as in Figure 3d, and another also of the type shown in Figure 3a, but wired to provide the other rail polarity as in FIG 3e.

10 Figure 7 shows a complementary field-effect transistor 4:2 compressor logic circuit comprising: OR/NOR gate 71A coupled to input signal X1 and input signal X2 and producing OR/NOR signal 81A; OR/NOR gate 71B coupled to input signal X3 and input signal X4 and producing OR/NOR signal 81B; AND/NAND gate 72A coupled to OR/NOR signal 81A and OR/NOR
15 signal 81B and producing a C-OUT signal; AND/NAND gate 72B coupled to input signal X1 and input signal X4 and producing AND/NAND signal 82B; AND/NAND gate 72C coupled to input signal X2 and input signal X3 and producing internal AND/NAND signal 82C; OR/NOR gate 71C coupled to internal AND/NAND signal 82B and internal AND/NAND 82C signal and
20 producing OR/NOR signal 81C; XOR/XNOR gate 73A coupled to input signal X1 and input signal X2 and producing internal XOR/XNOR signal 83A; XOR/XNOR gate 73B coupled to input signal X3 and input signal X4 and producing internal XOR/XNOR signal 83B; XOR/XNOR gate 73C coupled to internal XOR/XNOR signal 83A and internal XOR/XNOR signal 83B and
25 producing internal XOR/XNOR signal 83C; XOR/XNOR gate 73D coupled to internal XOR/XNOR signal 83C and a carry-in signal and producing an S output signal; and MUX/inverse-MUX gate 74 coupled to the carry-in signal and internal OR/NOR signal 81C and selected by internal XOR/XNOR signal 83C and producing a C output signal.

30 The WTGL design of Figure 7 has dual-rail inputs and generates dual-rail outputs. A SPICE circuit simulation (using Hewlett Packard 1.0 μm CMOS26 technology parameters shows that the typical WTGL total delay is

only 0.52 ns for the circuit of Figure 7 (which is equivalent to the sum of 3 inverter delays and 3 transmission gate delays), with the total delay variation less than 15%.

Comparisons to other wave-pipeline techniques show that the WTGL approach provides greater speed, as well as a flexible design. In addition, since the WTGL basic cell family is dual-rail and all the logic cells have the same gate delays, the basic cells were used and the routing was performed without inserting any padding elements.

10 WTGL cell library

The basic cell (SCMOS) library has been implemented, and several experimental circuits have been designed. The research results have revealed that the WTGL circuit family of the invention is suitable for CMOS wave-pipelining design and has certain advantages over other approaches.

15 Currently, several practical circuits are under design and will be fabricated by MOSIS.

Since the possible clocking speed of a wave-pipelined circuit can be as high as several hundred MHz and the frequency value is crucial for the circuit's functionality, on-chip clock-signal generation and manipulation is necessary, and related function modules such as high-frequency flip-flops and shift registers are also needed for wave-pipelined circuits. Currently, single-phase-clocked double-edge-triggered DFF's are being used as the I/O latches of the wave-pipelined functional block, to fully use the clock phases (i.e., both the rising edges and falling edges of the clock are used to clock the latches) and to partially alleviate the specific high-speed-data requirement (the clock speed is half of the data processing speed using this technique).

Logic Synthesis and Tuning Algorithms

Logic synthesis has been studied and explored over the past 30 years. Traditionally, efficient methods for implementing combinational logic in optimal two-level form using PLAs (Programmable-Logic Arrays) have been popular. Multilevel logic synthesis has been used in several systems such as

Logic Synthesis System (LSS) and MIS system of the University of California - Berkeley. A widely-accepted optimization criterion is to minimize the physical area while simultaneously satisfying the timing constraints (typically the block maximum and/or minimum delay parameters) derived from a
5 system-level analysis of the chip.

Considering the specific characteristics of the wave-pipelining technique, the conventional area and timing optimization goals are no longer appropriate for most cases. The ideal logic-synthesis algorithms for wave-pipelined systems should implement a certain function with a very high degree
10 of delay balance. Higher degree of balance will result in less total latency variations between different input-output paths measured by basic gate-delay resolution. Actually, for wave-pipelining design, rough-tuning algorithms are needed to modify the circuit to have the highest degree of balance by inserting delay elements, as described in references [Wong:89] and [Wong:93].

15 A tuning algorithm has been developed to go along with an ECL/CML wave-pipelined circuit design [Wong:93]. Notice that the rough-tuning algorithm assumes that an arbitrary combinational block is already available for modification, without considering the specific synthesis strategies required for wave-pipelining. It is believed necessary to integrate the logic synthesis
20 and rough-tuning algorithms, since they are closely related in terms of the general optimization goals such as area and timing constraints. In addition, because the WTGL technique has several available basic logic-circuit cells, each with the same gate-delay timing, the logic-synthesis and rough-tuning algorithms using WTGL as target technology would be more efficient. Also,
25 the availability of various basic cells with substantially equal delays necessitates a fresh look at the Boolean minimization problem to effectively utilize the logic blocks which are available using WTGL.

The Binary Decision Diagrams (BDDs) method has been widely used for logic verification and manipulation as described in references [Akers:78]
30 and [Bryant:86]. A more general form, called If-Then-Else Directed Acyclic Graphs (DAGs), has been successfully used for multi-level logic minimization

as described in references [Karplus:89] and [Karplus:91], with FPGAs as target technology.

All the basic circuit cells of WTGL can be defined by exactly one if-then-else operator:

- 5 $ab = (\text{if } a \text{ then } b \text{ else FALSE})$
- $a+b = (\text{if } a \text{ then TRUE else } b)$
- $a \text{ XOR } b = (\text{if } a \text{ then } \bar{b} \text{ else } b)$
- $ac+b\bar{c} = (\text{if } c \text{ then } a \text{ else } b)$

- In this case, the logic function, as well as the node-timing information
- 10 measured by basic gate delays, can be represented by if-then-else DAGs.
- Meanwhile, the rough-tuning algorithms can also use the Directed Acyclic Graph (DAG) representation of circuits, as described in reference [Wong:93]. Therefore, from this common starting point, it would be highly feasible to integrate the logic synthesis and rough tuning to generate more efficient and
- 15 powerful CAD tools for wave-pipelined circuit implementations with the WTGL basic cell library as target technology.

- For the fine-tuning algorithm, the detailed timing analysis of CMOS circuits will be focused upon, especially Transmission-Gate-based circuits. As the equivalent circuits of WTGL basic cells in Figures 5a through 5j indicate,
- 20 the gate delay can be determined by analysis of only a few charge and discharge equivalent circuits. Therefore, simple but effective delay models (which include the fanout information) play a significant role in the development of actual fine-tuning CAD algorithms. In addition, post-layout circuit extraction/simulation procedures should also be incorporated with the
 - 25 fine-tuning CAD tools.

- Wave-pipelining using the WTGL circuit family shows enormous potential for high-speed digital-system design. As the research described above has shown, the WTGL family, by providing substantially equal rise and fall times, and reduced input-pattern-caused gate-delay variations, overcomes
- 30 strict timing constraints often required by other wave-pipelining methods, without sacrificing the basic advantages of the wave-pipelined systems. The

analysis on the basic cells of the invention has shown a significant performance improvement over wave-pipelined systems formed by previously described methods.

The WTGL family of basic cells having substantially equal delays
5 allows the development of compact, high-speed circuits through logic synthesis. For instance, the WTGL technique has been shown to be a promising method for high-performance CFET wave-pipelined circuit design. It can be used in applications such as high-speed arithmetic units for high-performance computing systems and high-throughput digital-signal processors
10 for pattern-recognition and image-processing systems. This will surely help in the development of high-speed systems of the future.

It is to be understood that the above description is intended to be illustrative, and not restrictive. Many other embodiments will be apparent to those of skill in the art upon reviewing the above description. For instance,
15 an enhancement-mode Insulated-Gate Field-Effect Transistor (IGFET) technology is used in some of the embodiments (e.g., Figures 2b, 2d, and 3) described above, but a person skilled in the art could use an analogous method using, e.g., depletion-mode devices, or MESFETs. The scope of the invention should, therefore, be determined with reference to the appended
20 claims, along with the full scope of equivalents to which such claims are entitled.

References:

- [Akers:78] S. Akers, "Binary decision diagrams," IEEE Trans. on Computers , vol. C27, pp. 509–516, June 1978.
- 5 [Anderson:67] S. Anderson, J. Earle, R.E. Goldschmidt, and D.M. Powers, "The IBM System/360 Model 91: Floating-Point Execution Unit," IBM J. Research and development , vol. 11, pp. 34–53, January 1967.
- [Bryant:86] R. Bryant, "Graph-based algorithms for Boolean function manipulation," IEEE Trans. on Computers , 10 vol. C35, pp. 677–691, August 1986.
- [Cotten:69] L. Cotten, "Maximum-rate Pipeline Systems" in AFIPS Proceeding of Spring Joint Computer Conference , pp. 581–586, 1969.
- 15 [Ekroot:87] B. Ekroot, "Optimization of Pipelined Processors by Insertion of Combinational Logic Delay," PhD thesis, Stanford University, Dept. Elect. Eng., Stanford Univ., Stanford, CA, Sept. 1987.
- [Fan:92] D. Fan, C. Gray, W. Farlow, T. Hughes, W. Liu, and R. Cavin, "A CMOS Parallel Adder Using Wave 20 Pipelining," in Advanced Research in VLSI and Parallel Systems, (MIT, U.S.A.), 1992.
- [Gray:91] C. Gray, T. Hughes, S. Arora, W. Liu, and R. Cavin, "Theoretical and Practical Issues in CMOS Wave 25 Pipelining," in VLSI 91, (Edinburgh, U.K.), pp. 397–409, August 1991.
- [Joy:91] D. Joy and M. Ciesielski, "Placement for Clock Period Minimization with Multiple Wave Propagation," in 28th ACM/IEEE Design Automation Conference , (San Francisco, CA), pp. 640–643, June 1991.
- 30 [Karplus:89] K. Karplus, "Using if-then-else DAGs for multi-level logic minimization," in Proc. Advanced Research in VLSI'89 , (UC Santa Cruz, CA), pp. 101–117, 1989.

- [Karplus:91] K. Karplus, "Amap: A technology mapper for selector-based Field-Programmable Gate Arrays," in Proc. 28th Design Automation Conference , 1991.
- 5 [Klass:92] F. Klass and J. Mulder, "Use of CMOS technology in Wave Pipelining," in Proc. 5th Conf. VLSI Design , (Bangalore, India), pp. 303–308, January 1992.
- [Klass:93a] F. Klass, M. Flynn, and A.V.D. Goor, "Fast Multiplication in VLSI Using Wave Pipelining Techniques," To appear in J. of VLSI Signal Processing.
- 10 [Klass:93b] F. Klass, M. Flynn, and A.V.D. Goor, "Pushing the limits of CMOS Technology: A Wave-pipelined Multiplier," in Workshop of Hot Chips V , (Stanford Univ., CA), August 1993.
- [Lam:92] W. Lam, R. Brayton, and A. Sangiovanni-Vincentelli, 15 "Valid Clocking in Wave-pipelined Circuits," in Proceeding of ICCAD'92 , (San Diego, CA), May 1992.
- [Shimohigashi:93] K. Shimohigashi and K. Seki, "Low-Voltage ULSI Design," IEEE Journal of Solid State Circuits, vol. 28, April 1993.
- 20 [Weste:93] N. Weste and K. Eshraghian, Principles of CMOS VLSI Design, Addison-Wesley 2nd edition, 1993.
- [Wong:89] D. Wong, G.D. Micheli, and M. Flynn, "Inserting Active Delay Elements to Achieve Wave Pipelining," in Proc. Int. Conf. CAD'89, (Santa Clara, CA), pp. 270– 25 273, 1989.
- [Wong:91] D.C. Wong, "Techniques for designing high-performance digital circuits using wave pipelining," PhD thesis, Stanford University, Dept. Elect. Eng., Stanford Univ., Stanford, CA, Aug. 1991.
- 30 [Wong:93] D.C. Wong, G. Micheli, and M. Flynn, "Designing High-Performance Digital Circuits Using Wave Pipelining: Algorithms and Practical Experiences," IEEE

Tran. CAD of Integrated Circuits and Systems , vol. 12,
pp. 25--46, January 1993.

[Yano:90]

5

K. Yano, T. Yamanaka, T. Nishida, M. Saito, K.
Shimohigashi, and A. Shimizu, "A 3.8ns CMOS -b
Multiplier Using Complementary Pass-Transistor Logic
,," IEEE J. Solid-State Circuits , vol. 25, pp. 388--395,
April 1990.

[Zhang:93]

10

X. Zhang and R. Sridhar, "CMOS Wave Pipelining
Using Complementary Pass-transistor Logic," Submitted
to IEEE J. Solid-State Circuits, in review, August 1993.

WHAT IS CLAIMED IS:

1. A logic circuit for performing a logic function, said logic circuit comprising:
 - 5 a first field-effect transistor having a first terminal coupled to a first input signal, a second terminal coupled to an internal node, and a gate coupled to a second input signal;
 - a second field-effect transistor having a first terminal coupled to said first input signal, a second terminal coupled to said internal node, and a gate
 - 10 coupled to a logical complement of said second input signal;
 - a third field-effect transistor having a first terminal coupled to a voltage source, a second terminal coupled to said internal node, and a gate coupled to said second input signal;
 - a driver coupled to said internal node, said driver comprising means
 - 15 for amplifying a voltage, adjusting logic levels, and providing an output signal; and
 - a plurality of paths to said output from said first input signal, said second input signal, and said logical complement of said second input signal, respectively, each of said plurality of paths having substantially equal delays.
 - 20
2. A logic circuit according to claim 1 wherein:
 - said first field-effect transistor has a first channel type;
 - said second field-effect transistor has a second channel type which is complementary to said first channel type; and
 - 25 said third field-effect transistor has said second channel type.
3. A logic circuit according to claim 2 wherein:
 - said first channel type is an N-channel enhancement-mode channel;
 - said second channel type is a P-channel enhancement-mode channel;
 - 30 and
 - said voltage source is V_{DD} .

4. A logic circuit according to claim 3 wherein:
said logic function is a logical AND.
5. A logic circuit according to claim 3 wherein:
5 said logic function is a logical NOR.
6. A logic circuit according to claim 2 wherein:
said first channel type is a P-channel enhancement-mode channel;
said second channel type is an N-channel enhancement-mode channel;
10 and
said voltage source is ground.
7. A logic circuit according to claim 6 wherein:
said logic function is a logical NAND.
15
8. A logic circuit according to claim 6 wherein:
said logic function is a logical OR.
9. A logic circuit comprising:
20 a transmission gate having a first terminal coupled to a first input
signal, a second terminal coupled to a node, and a gate coupled to a second
input signal;
a pull transistor having a first terminal coupled to a voltage source, a
second terminal coupled to said node, and a gate coupled to a third input
25 signal; and
a driver coupled to said node, said driver comprising means for
amplifying a voltage, adjusting logic levels, and providing an output signal.
10. A logic circuit according to claim 9 wherein said transmission gate
30 comprises complementary field-effect transistors.

11. A logic circuit according to claim 10 wherein said complementary field-effect transistors comprise:

at least one N-channel enhancement-mode transistor; and
at least one P-channel enhancement-mode transistor.

5

12. A complementary field-effect transistor logic circuit comprising:

a first pass transistor having a first channel type and having a first terminal coupled to a first input signal, a second terminal coupled to an internal node, and a gate coupled to a second input signal;

10 a second pass transistor having a second channel type which is complementary to said first channel type and having a first terminal coupled to said first input signal, a second terminal coupled to said internal node, and a gate coupled to a logical complement of said second input signal;

a third transistor having said second channel type and having a first
15 terminal coupled to a voltage terminal, a second terminal coupled to said internal node, and a gate coupled to said second input signal; and

a driver coupled to said internal node, comprising means for amplifying a voltage and adjusting logic levels at an output signal.

20 13. A family of logic circuits for performing logic functions, said family comprising:

a first logic circuit comprising:

a first field-effect transistor having a first terminal
coupled to a first input signal, a second terminal coupled to a
25 first internal node, and a gate coupled to a second input signal;

a second field-effect transistor having a first terminal
coupled to said first input signal, a second terminal coupled to
said first internal node, and a gate coupled to a logical
complement of said second input signal;

30 a third field-effect transistor having a first terminal
coupled to a voltage source, a second terminal coupled to said

first internal node, and a gate coupled to said second input signal; and

a first driver coupled to said first internal node, said first driver comprising means for amplifying a voltage, adjusting logic levels, and providing a first output signal;

a second logic circuit comprising:

a first and a second transmission gate, wherein said first and second transmission gates have substantially equivalent output transition times and substantially equivalent propagation delay times, and wherein each of said first and second transmission gates comprise:

a fourth field-effect transistor having a first terminal coupled to a third input signal, a second terminal coupled to a second internal node, and a gate coupled to a fourth input signal; and

a fifth field-effect transistor having a first terminal coupled to said third input signal, a second terminal coupled to said second internal node, and a gate coupled to a logical complement of said fourth input signal; and

a second driver coupled to said internal nodes of each of said first and second transmission gates, wherein said driver comprises means for amplifying a voltage, adjusting logic levels, and providing a second output signal; and

wherein said first and second logic circuits have substantially equivalent output transition times and substantially equivalent propagation delay times.

14. A logic circuit for performing a wave-pipelined logic function, said logic circuit comprising:

a first, second, third, and fourth logic circuit, each of said logic circuits comprising:

a first field-effect transistor (FET) having a first terminal coupled to a first input signal, a second terminal coupled to a first internal node, and a gate coupled to a second input signal;

5 a second FET having a first terminal coupled to said first input signal, a second terminal coupled to said first internal node, and a gate coupled to a logical complement of said second input signal;

10 a third FET having a first terminal coupled to a voltage source, a second terminal coupled to said first internal node, and a gate coupled to said second input signal; and

a driver coupled to said first internal node, said driver comprising means for amplifying a voltage, adjusting logic levels, and providing a first output signal;

15 said first and second logic circuits forming a first stage and said third and fourth logic circuits forming a second stage, said output of said first logic circuit being coupled as said second input signal for said third logic circuit, said output of said second logic circuit being coupled as said logical complement of second input signal for said third logic circuit, said first FET of said first and third logic circuits and said second and third FETs of said
20 second and fourth logic circuits each having a first channel type, said first FET of said second and fourth logic circuits and said second and third FETs of said first and third logic circuits each having a second channel type, and said first, second, third, and fourth logic circuits having substantially equivalent output transition times and substantially equivalent propagation
25 delay times.

15. A logic circuit for performing a logic function which generates a result, the result having both a first output signal and a second output signal, the second output signal being a logical complement of the first output signal,
30 both output signals having substantially equivalent output transition times and substantially equivalent propagation delay times relative to any input signal transition, the circuit comprising:

a first field-effect transistor having a first terminal coupled to a first input signal, a second terminal coupled to a first internal node, and a gate coupled to a second input signal;

5 a second field-effect transistor having a first terminal coupled to the first input signal, a second terminal coupled to the first internal node, and a gate coupled to a logical complement of the second input signal;

a third field-effect transistor having a first terminal coupled to a first voltage source, a second terminal coupled to the first internal node, and a gate coupled to the logical complement of the second input signal;

10 a first driver coupled to the first internal node, the first driver comprising means for amplifying a voltage, adjusting logic levels, and providing the first output signal;

a fourth field-effect transistor having a first terminal coupled to a logical complement of the first input signal, a second terminal coupled to a second internal node, and a gate coupled to the second input signal;

15 a fifth field-effect transistor having a first terminal coupled to the logical complement of the first input signal, a second terminal coupled to the second internal node, and a gate coupled to the logical complement of the second input signal;

20 a sixth field-effect transistor having a first terminal coupled to a second voltage source, a second terminal coupled to the second internal node, and a gate coupled to the second input signal; and

a second driver coupled to the second internal node, the second driver comprising means for amplifying a voltage, adjusting logic levels, and
25 providing the second output signal.

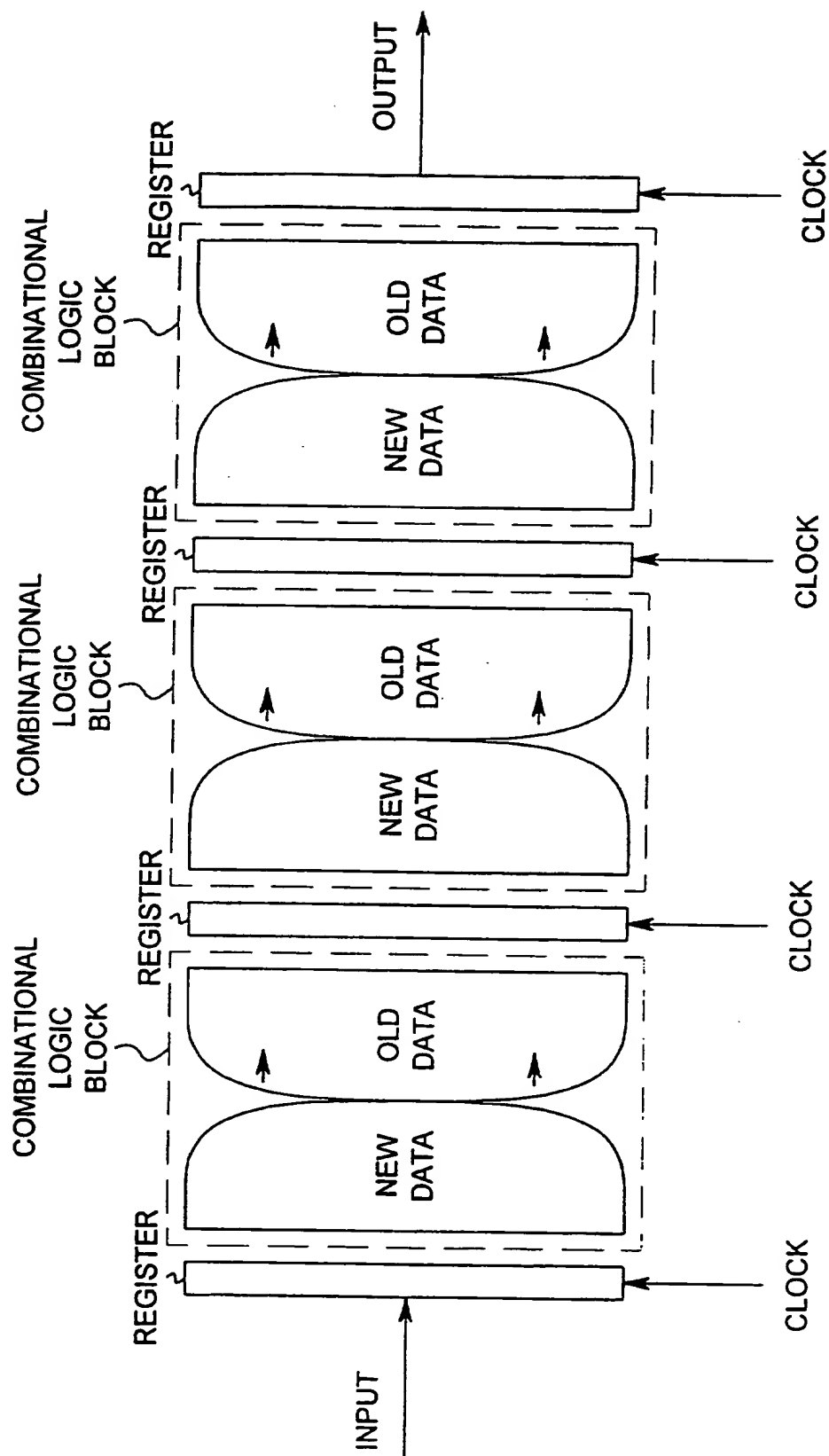


FIG. 1a PRIOR ART

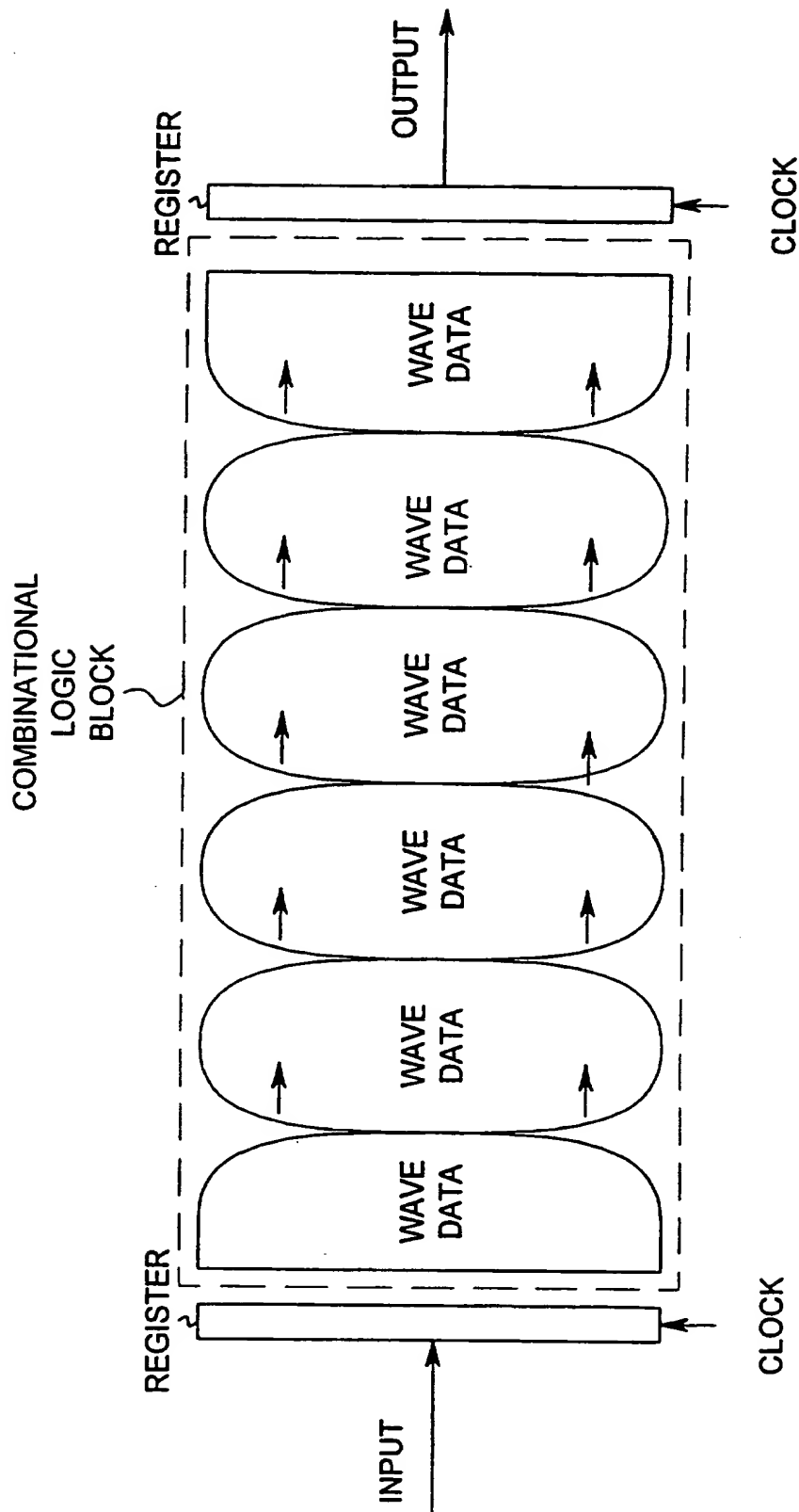


FIG. 1b PRIOR ART

3/23

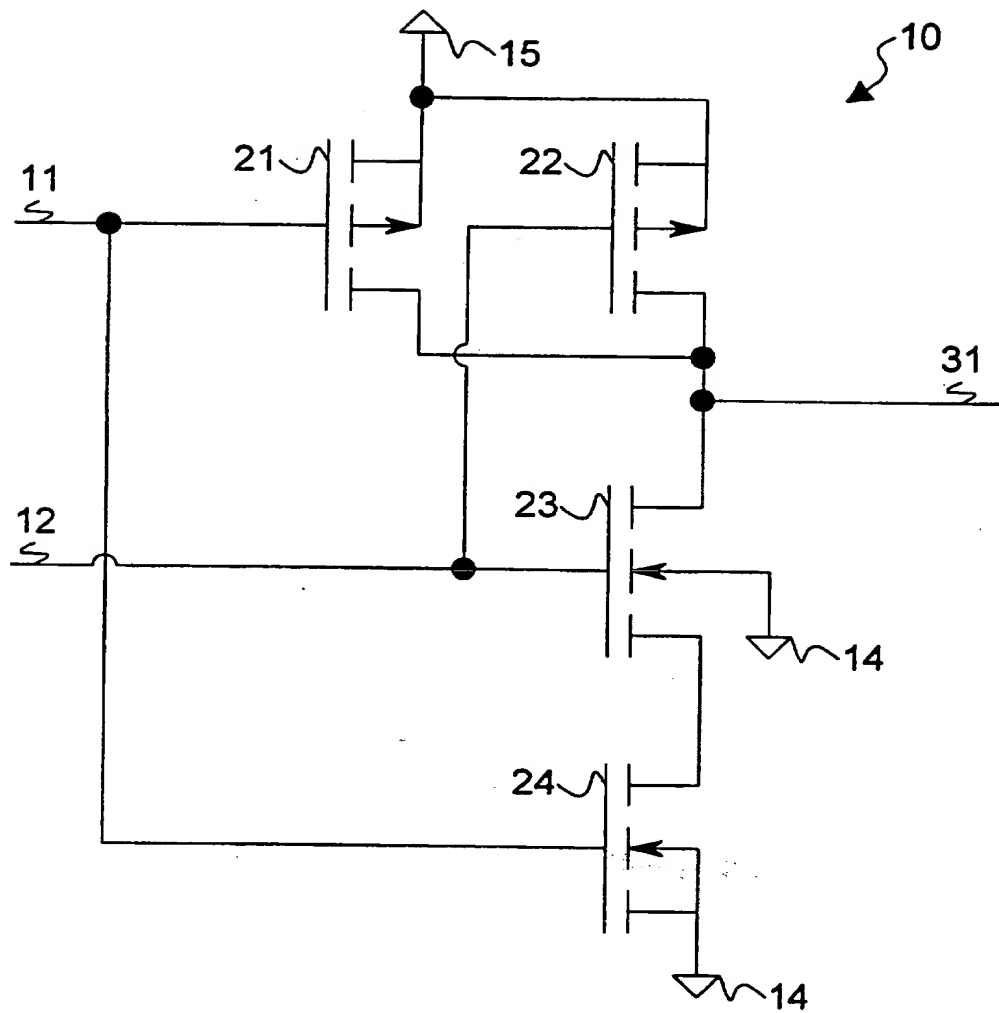
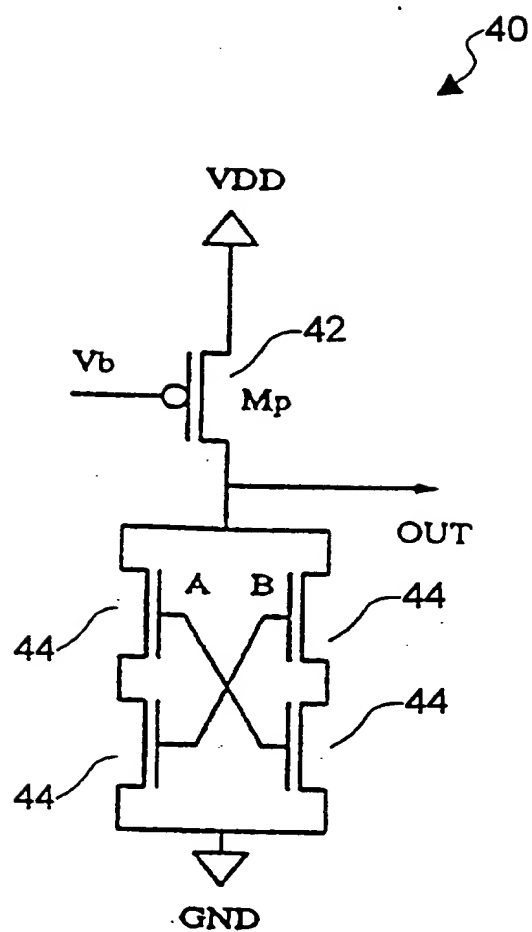
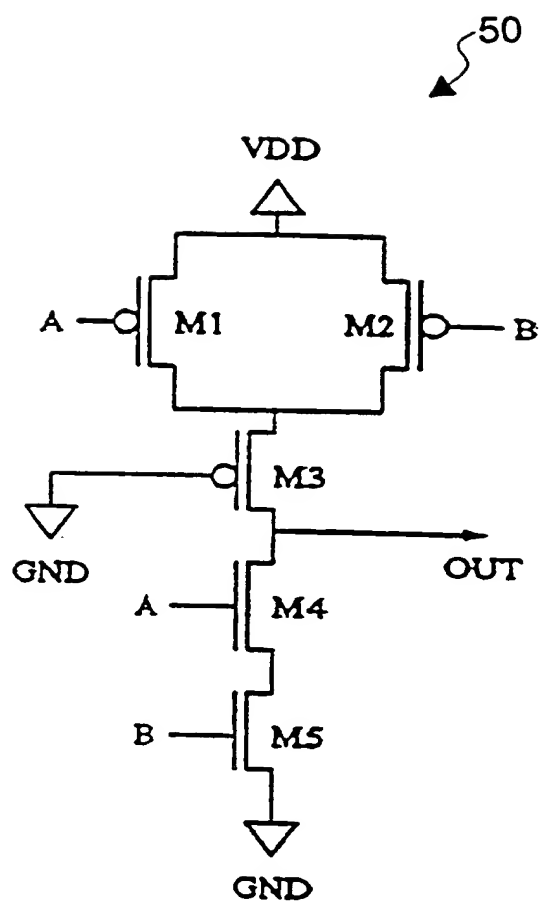
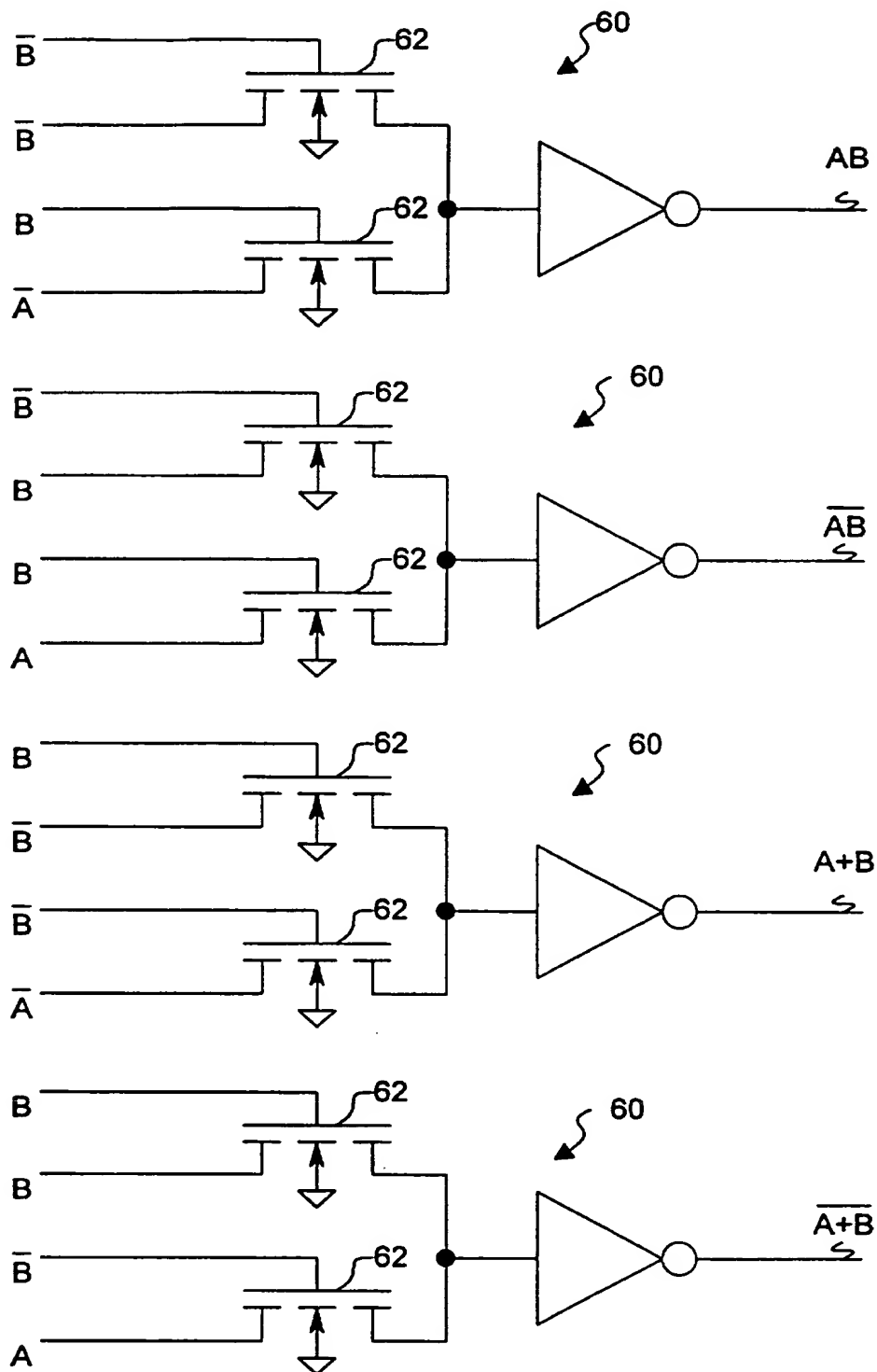


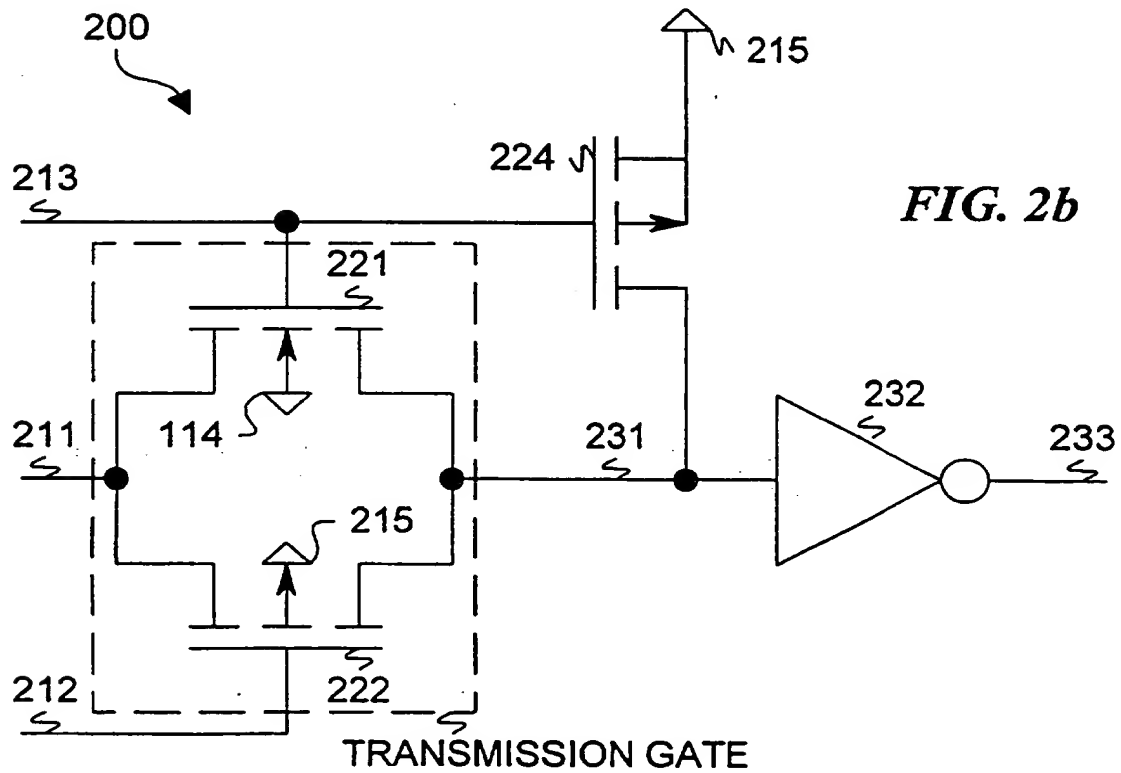
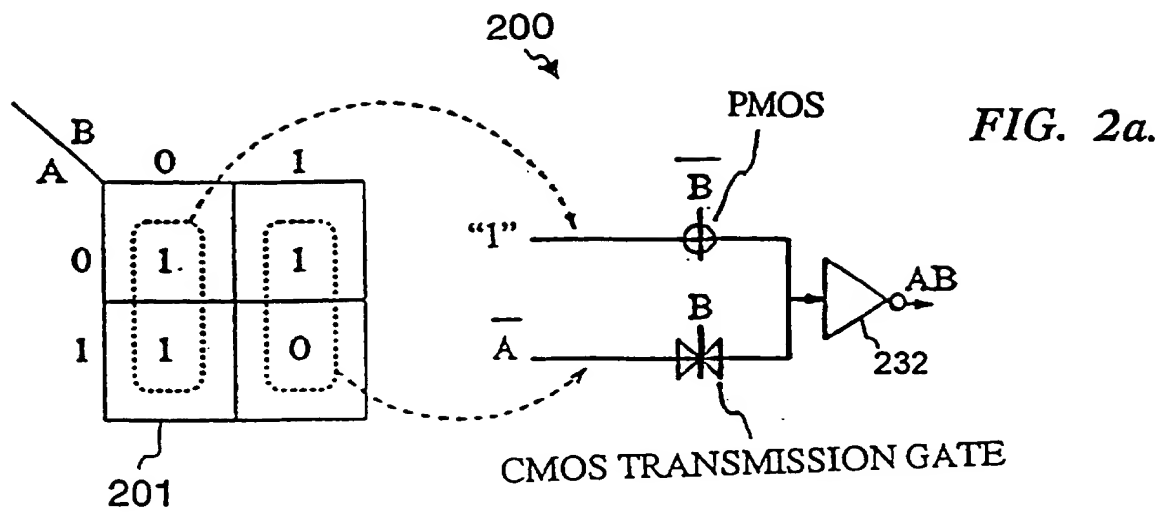
FIG. 1c **PRIOR ART**

**FIG. 1d PRIOR ART****FIG. 1e PRIOR ART**

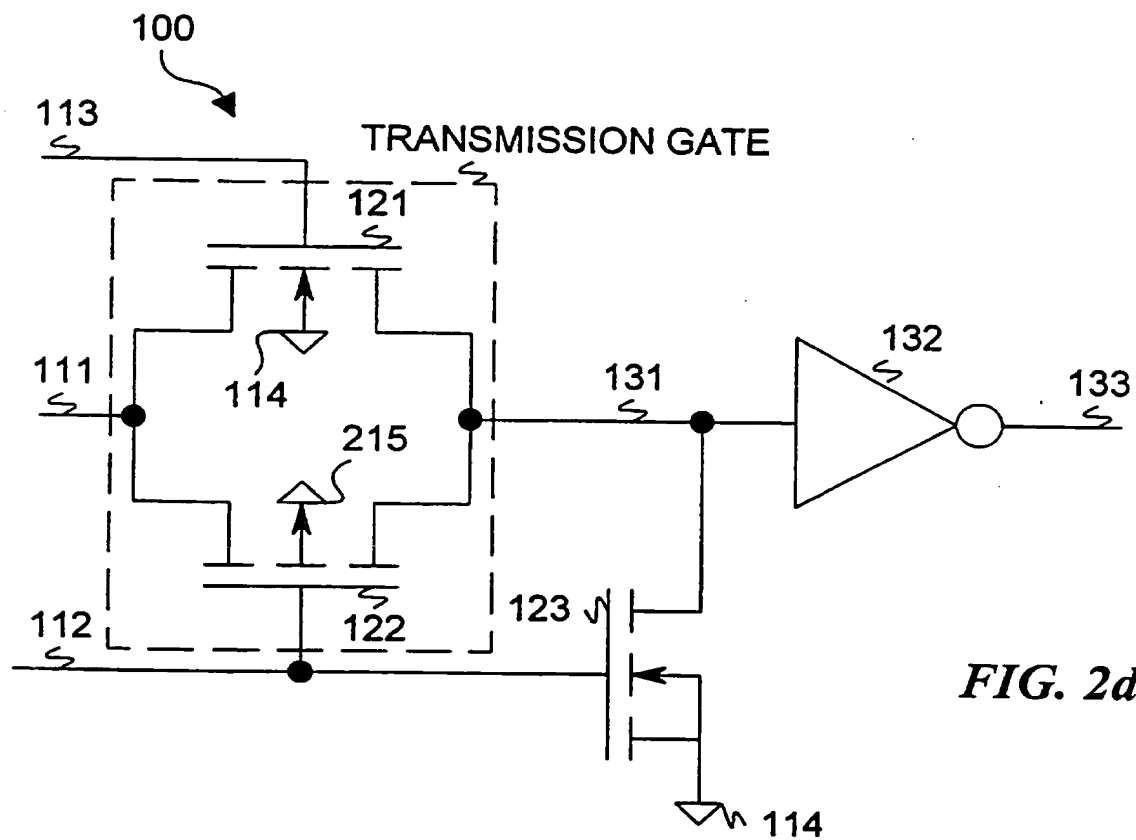
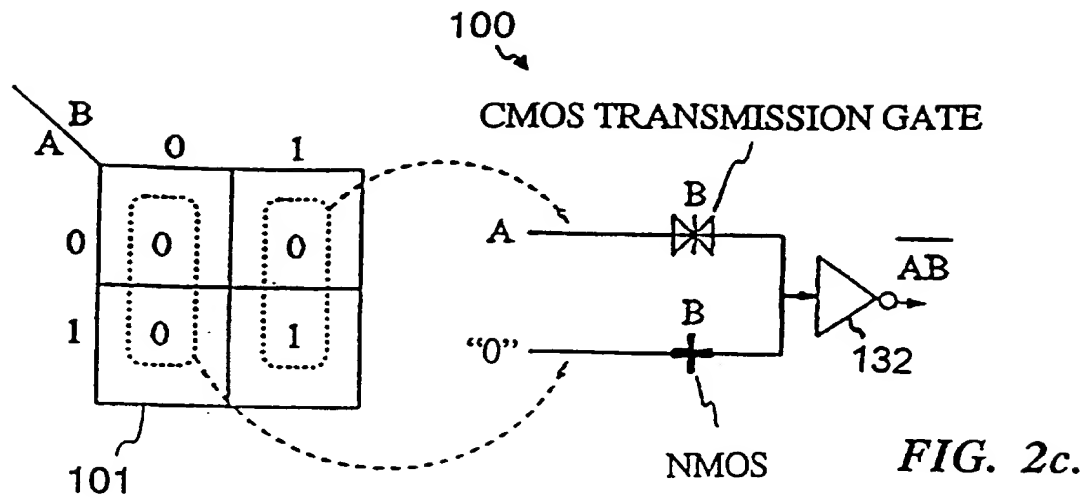
5/23

**FIG. 1f PRIOR ART**

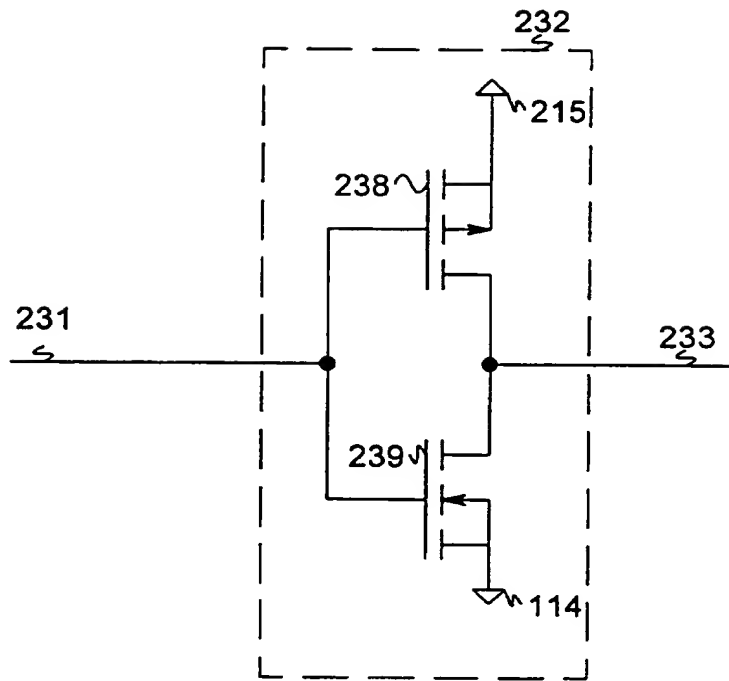
6/23



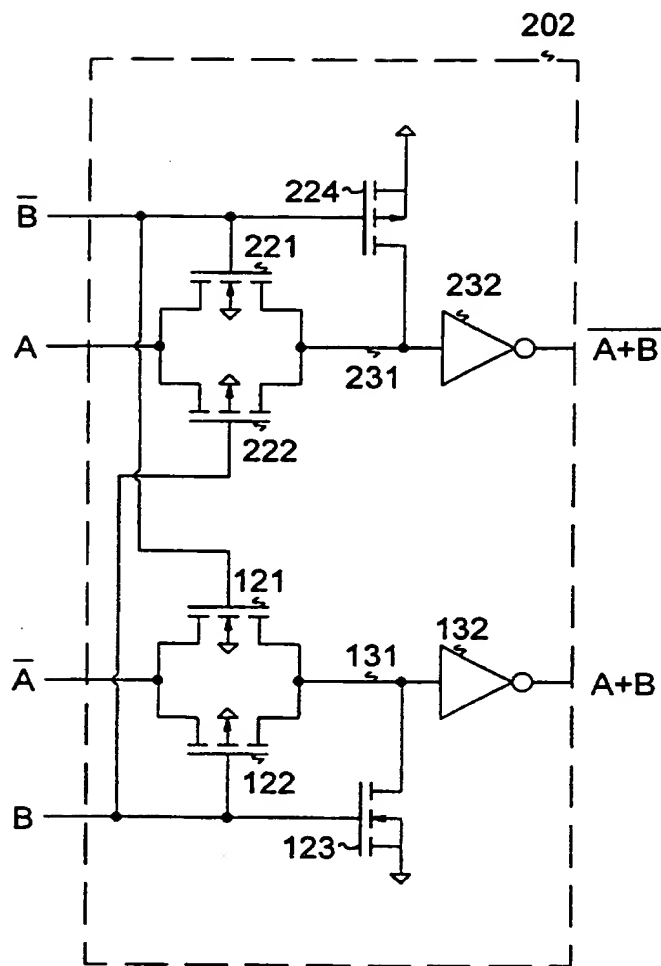
7/23



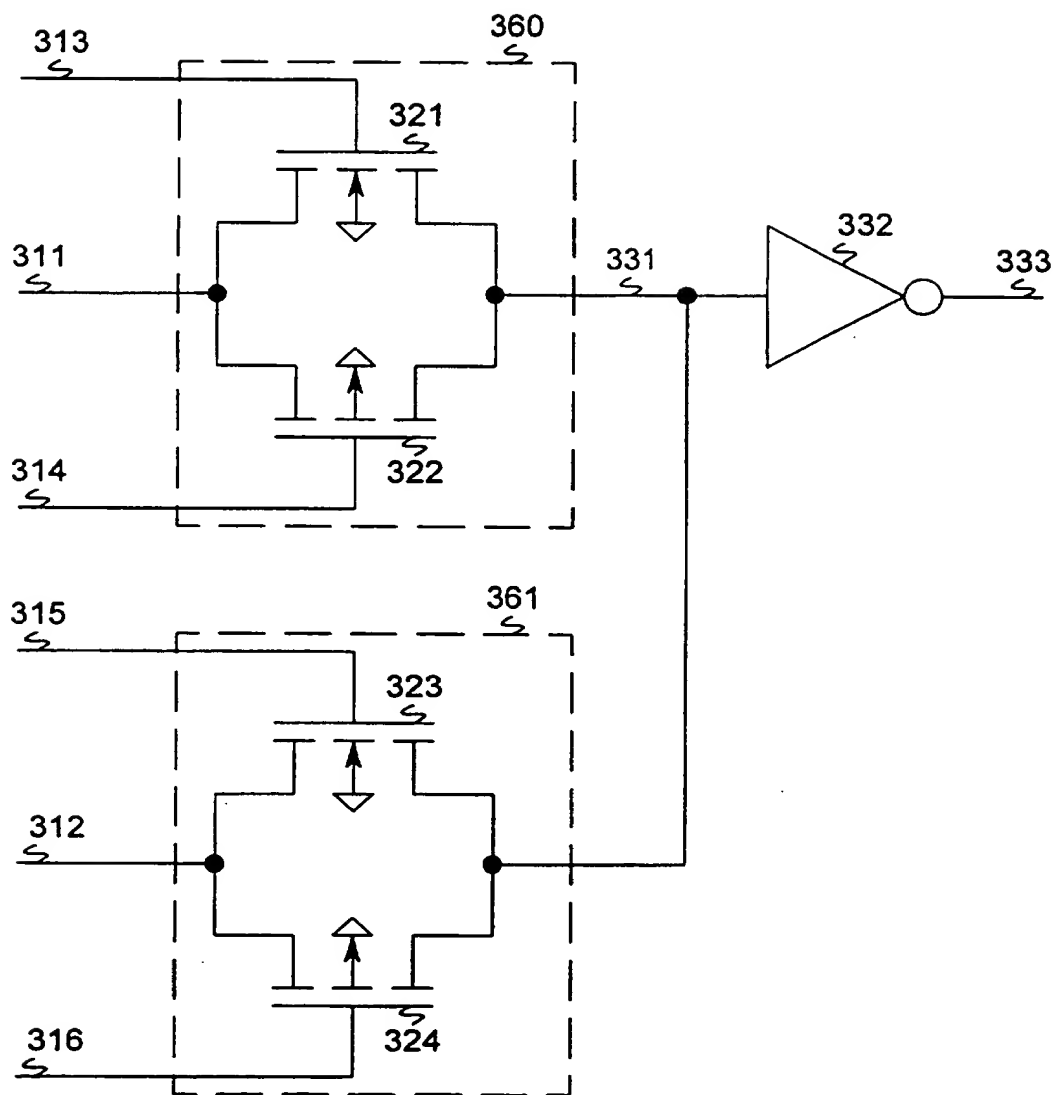
8/23

*FIG. 2e*

10/23

FIG. 2g

11/23

*FIG. 3a*

12/23

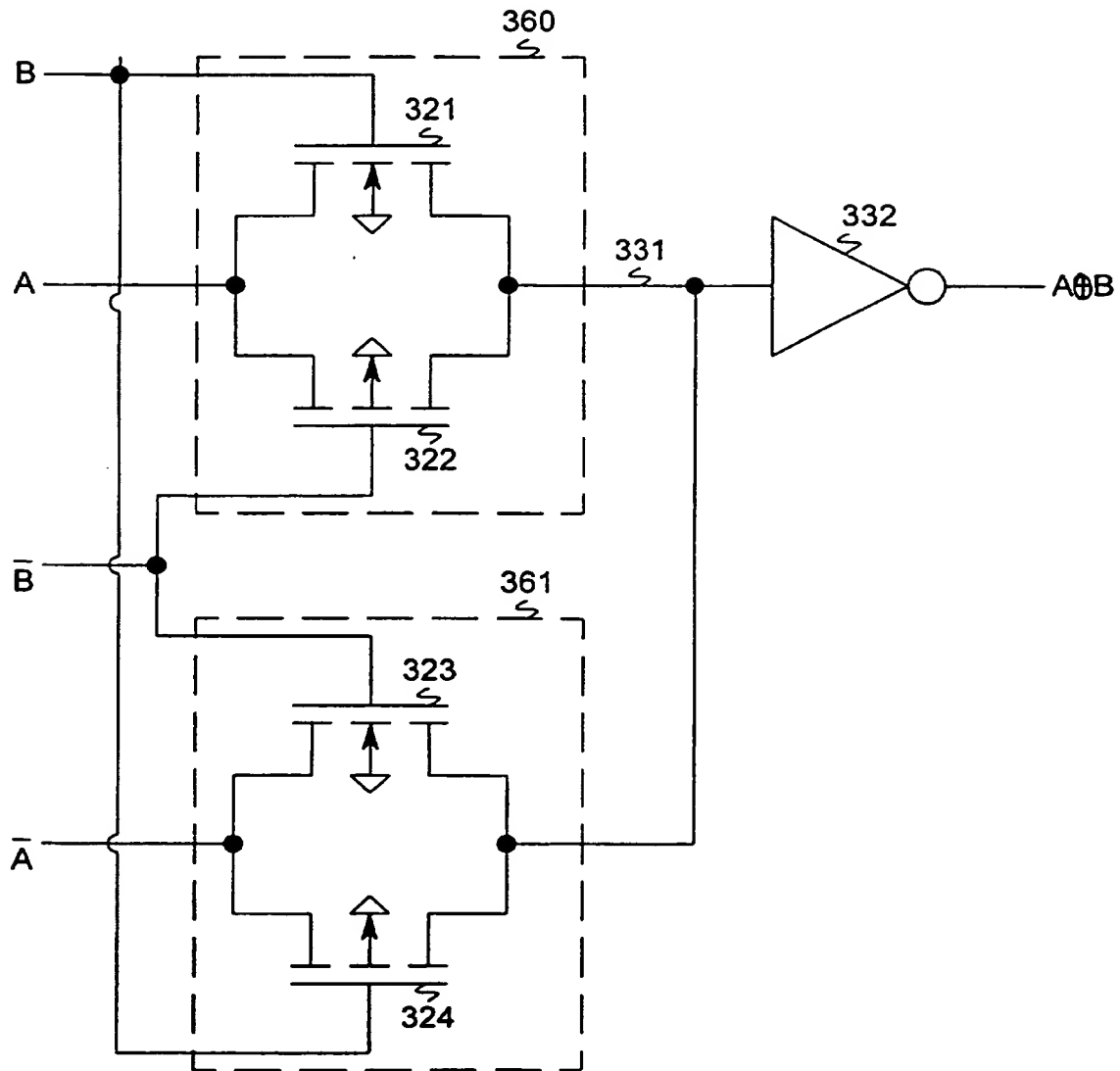
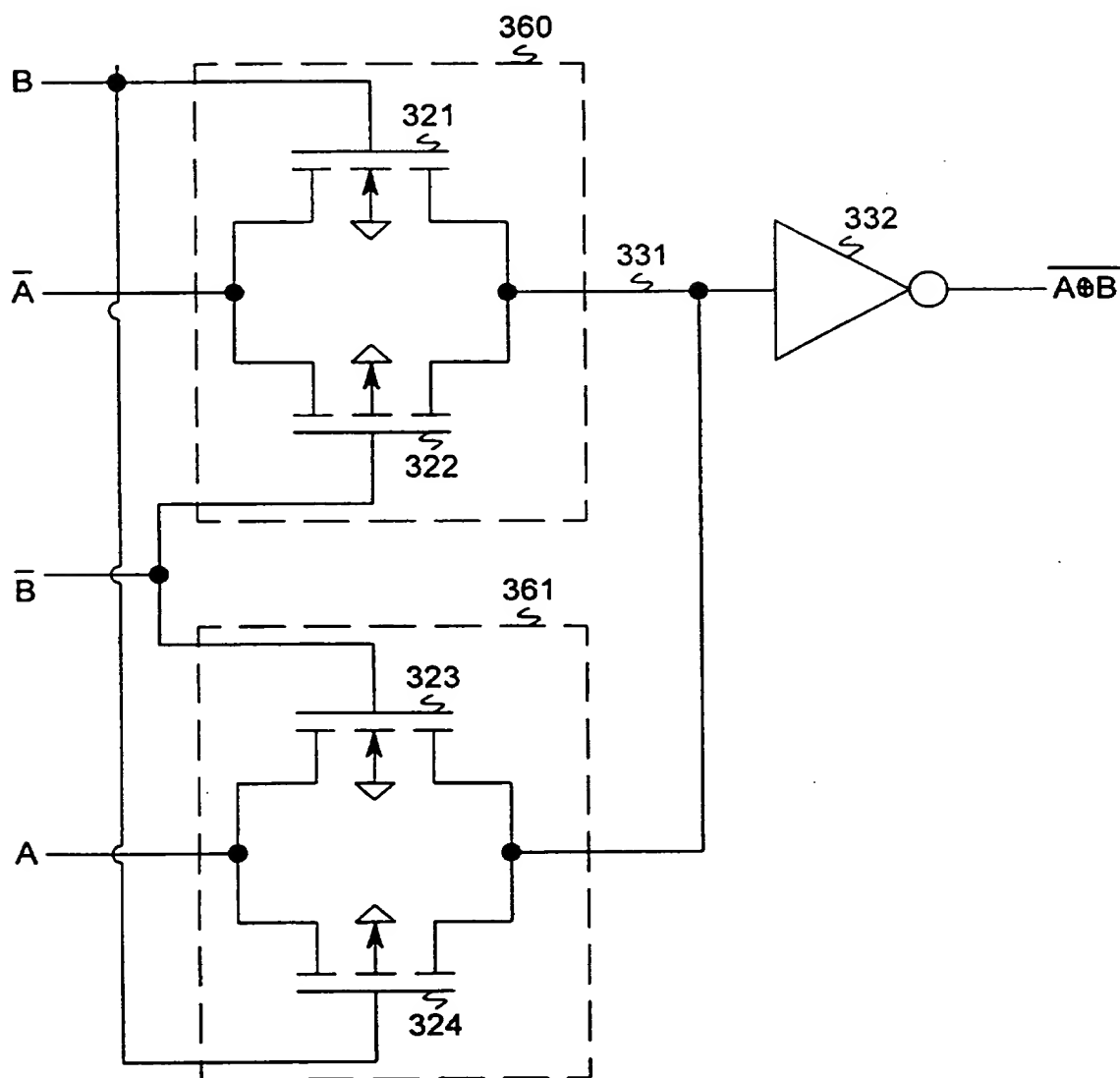


FIG. 3b

13/23

**FIG. 3c**

14/23

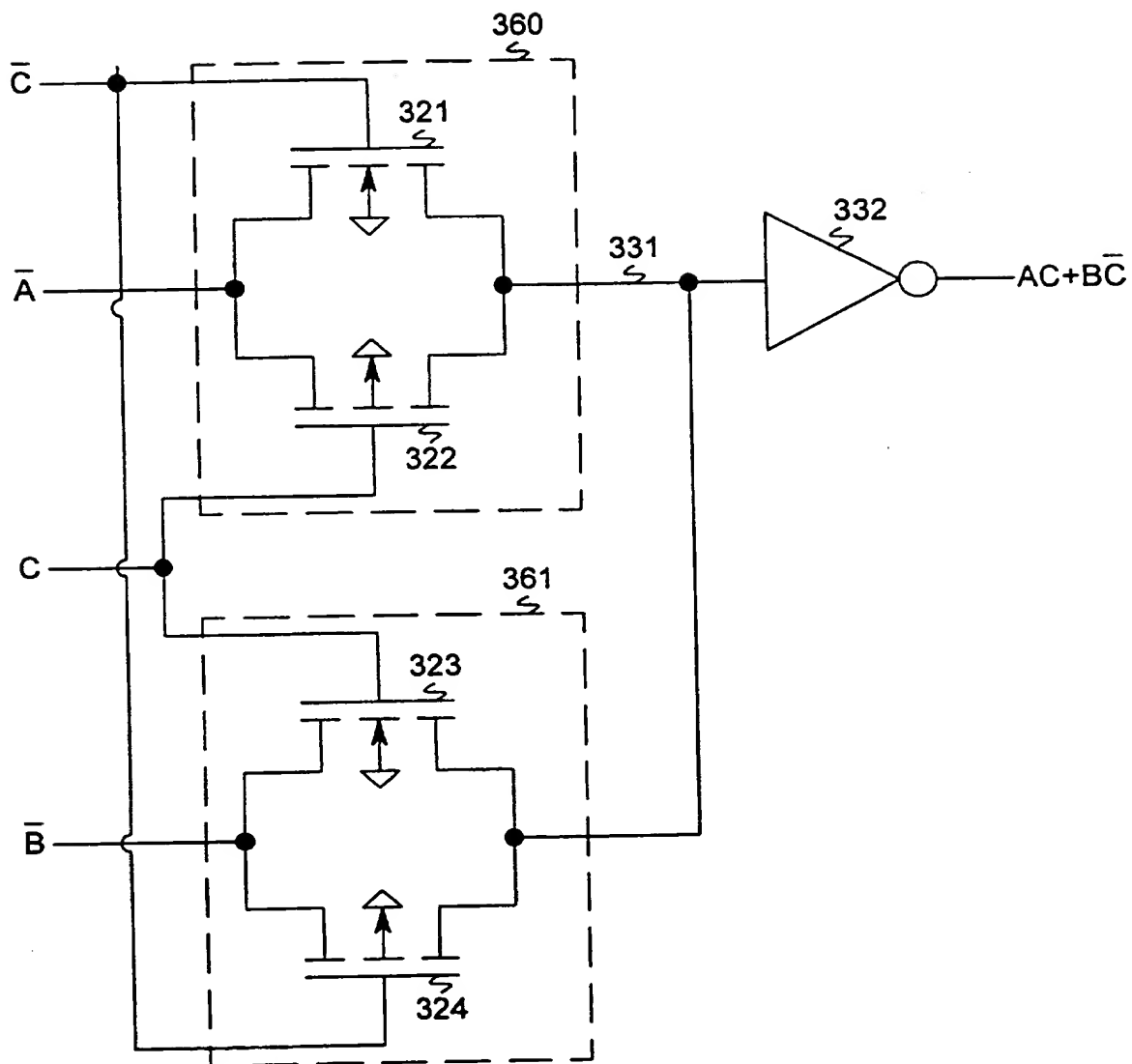
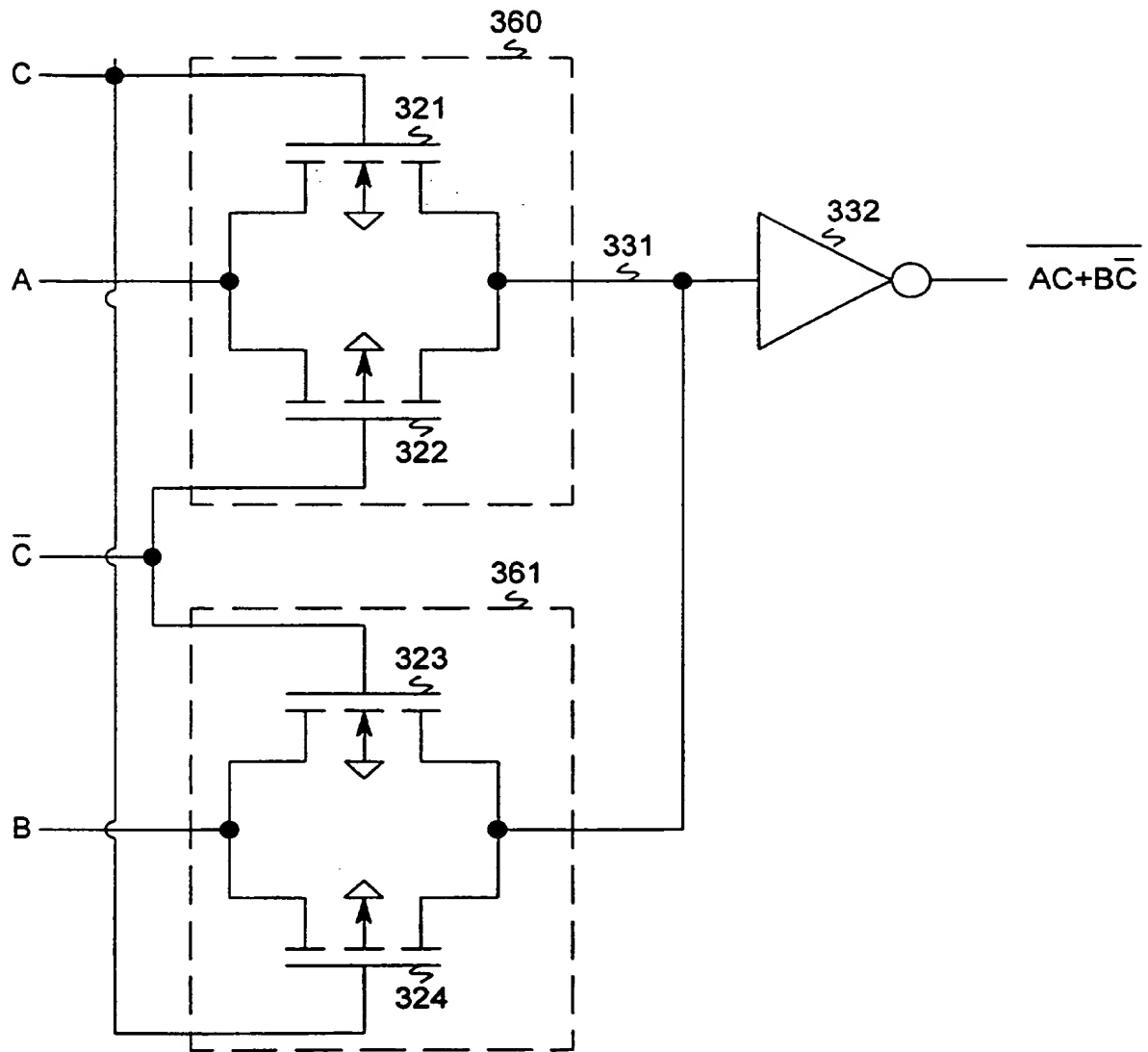


FIG. 3d

15/23

**FIG. 3e**

16/23

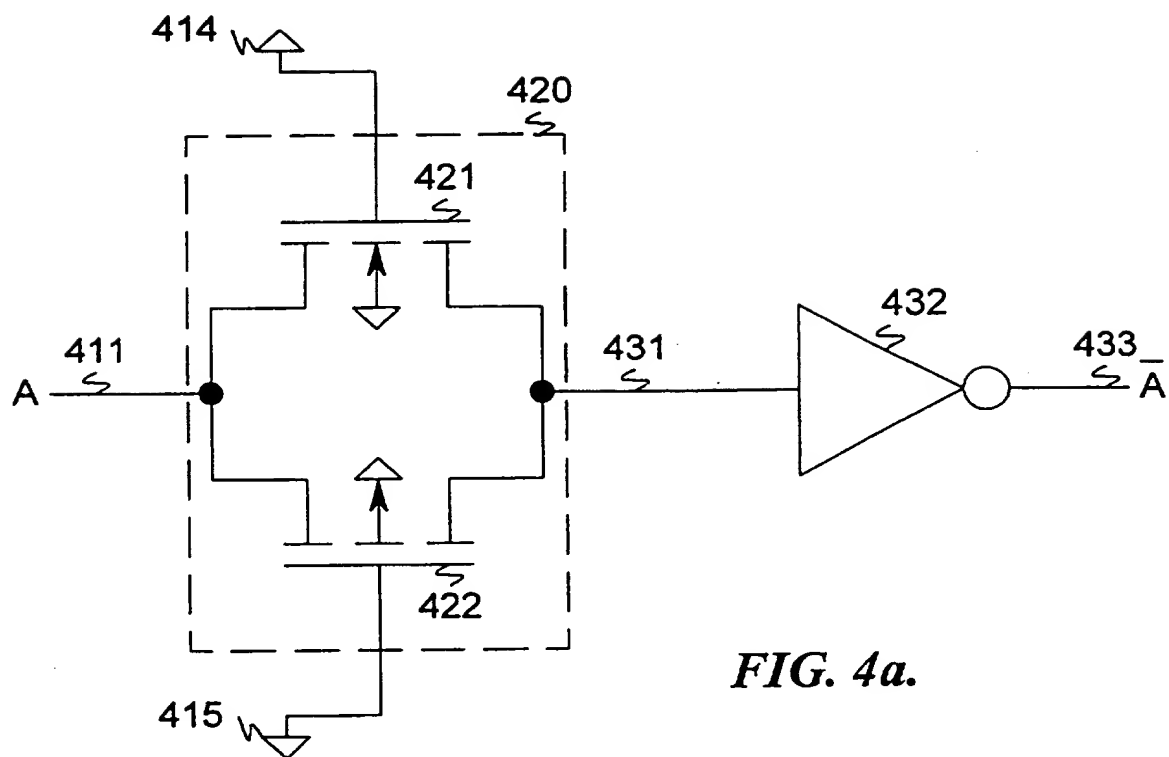


FIG. 4a.

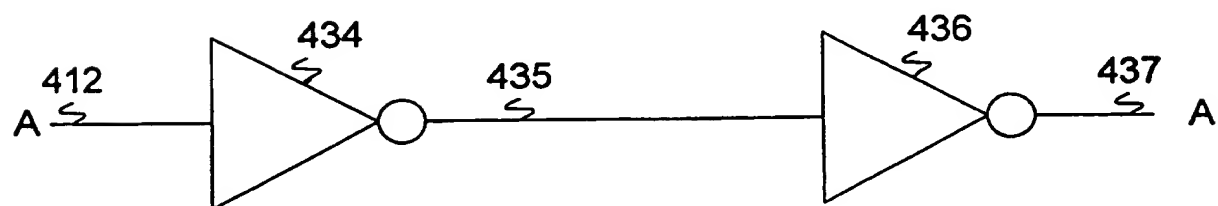


FIG. 4b.

FIG. 5b

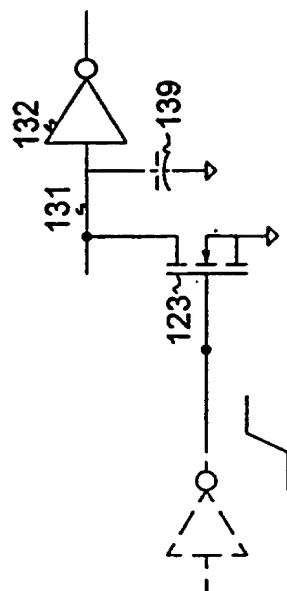
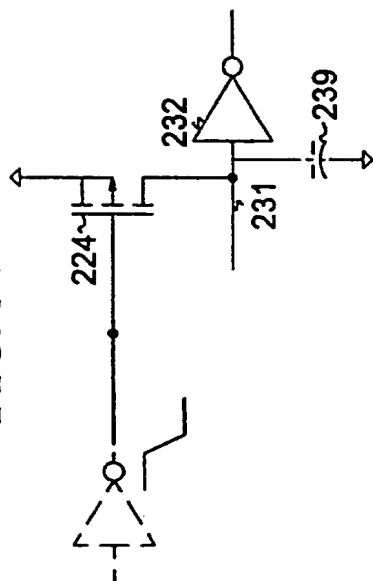


FIG. 5a



18/23

FIG. 5d

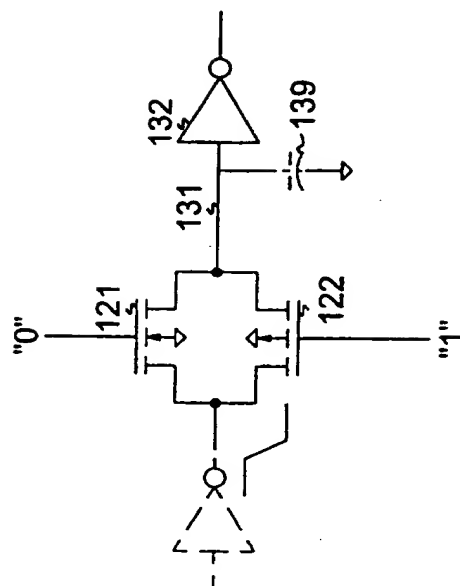


FIG. 5c

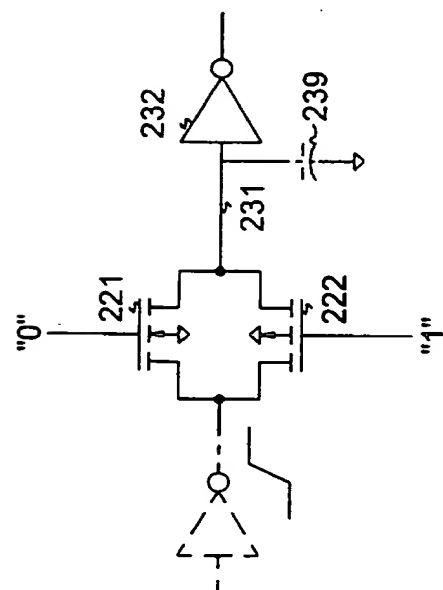


FIG. 5f

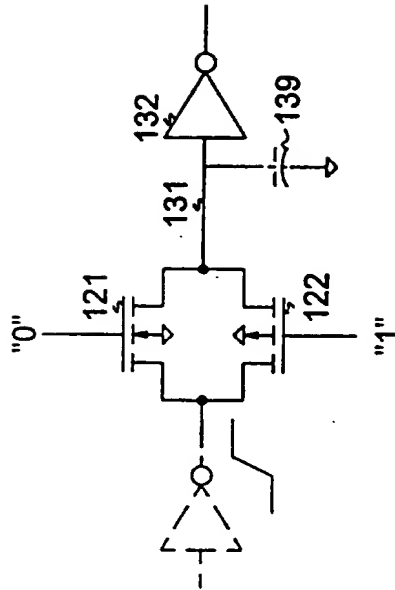


FIG. 5e

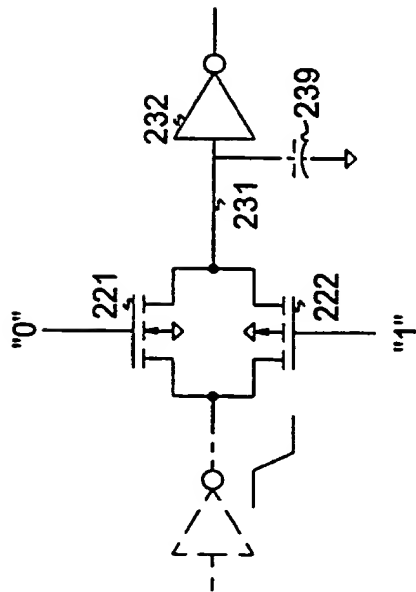


FIG. 5h

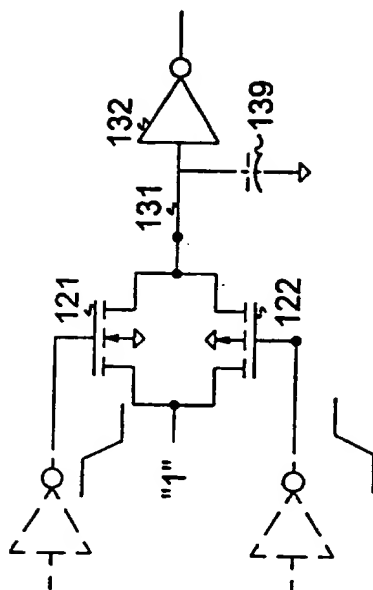


FIG. 5g

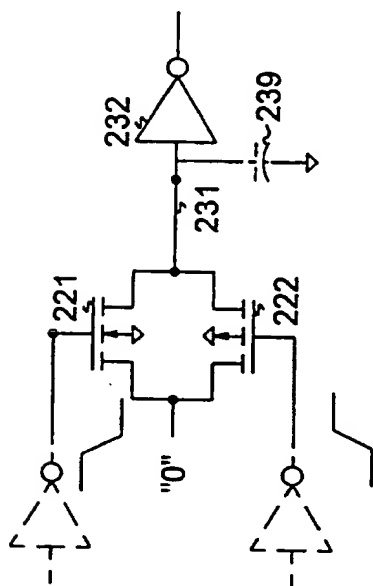


FIG. 5j

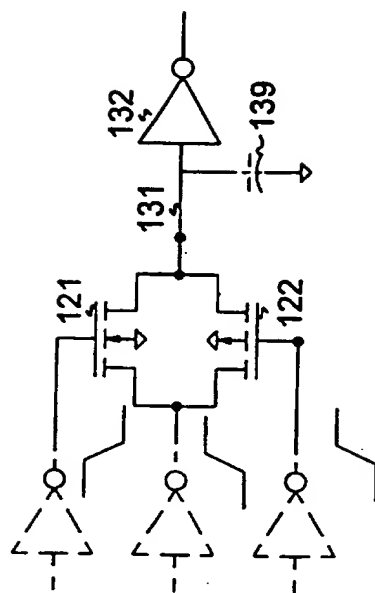
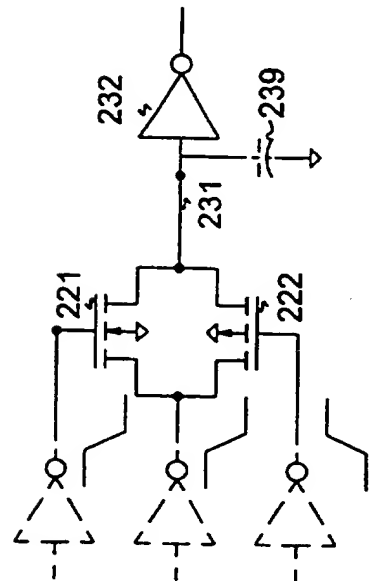


FIG. 5i



22/23

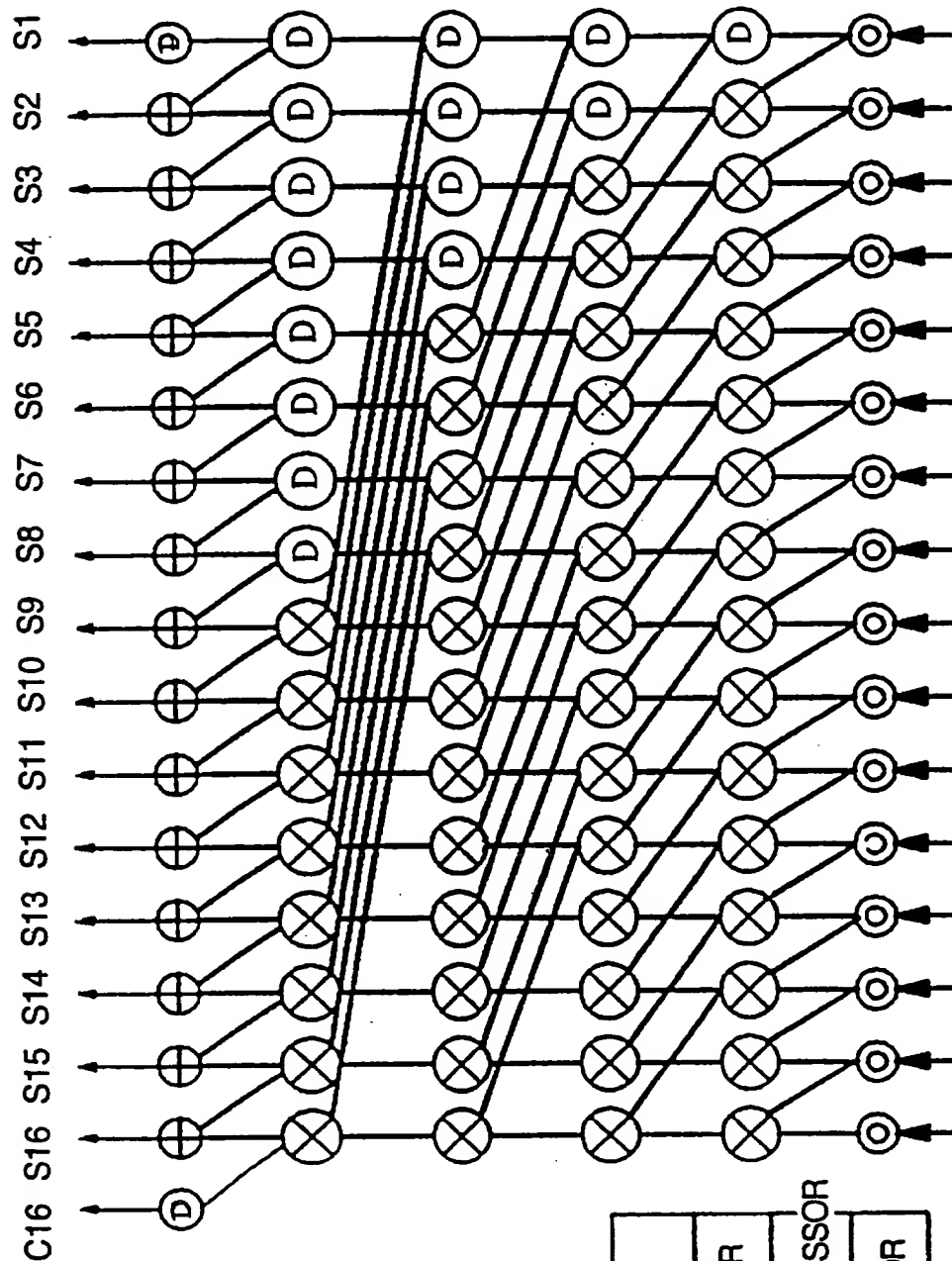


FIG. 6.

⊕	XOR
D	DELAY BUFFER
⊗	BLACK PROCESSOR
⊙	PG GENERATOR

INPUT OPERAND BUFFERS

23/23

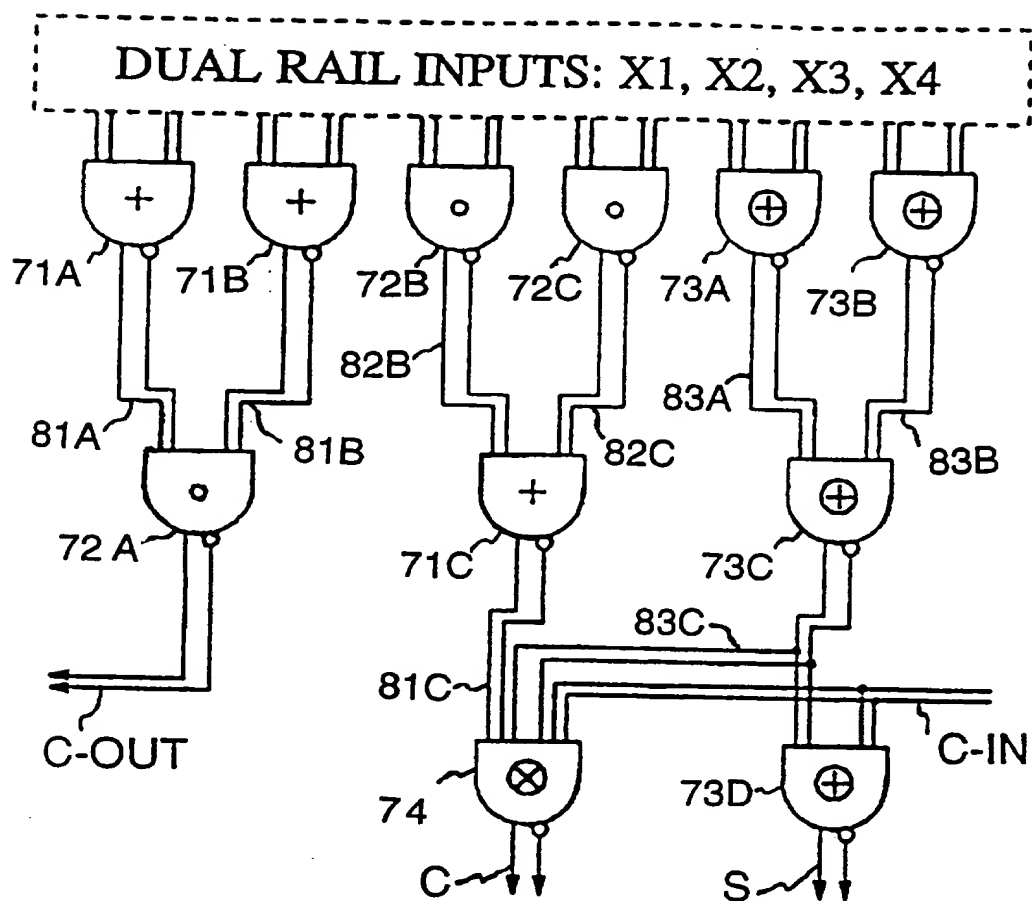


FIG. 7

INTERNATIONAL SEARCH REPORT

.national application No.
PCT/US95/11589

A. CLASSIFICATION OF SUBJECT MATTER

IPC(5) :G06F 7/48

US CL :326/113

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

U.S. : 326/113, 114, 21; 327/161, 170

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	US, A, 4,620,117 (Fang) 28 October 1986, Figs. 2b, 2c, 8.	1-15
X	US, A, 5,200,907 (Tran) 06 April 1993, Fig. 3.	9-11
A	US, A, 4,710,649 (Lewis) 01 December 1987, Figs. 1A-2D.	1-15

☐ Further documents are listed in the continuation of Box C. ☐ See patent family annex.

* Special categories of cited documents:	* T	later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
* A* document defining the general state of the art which is not considered to be of particular relevance	* X	document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
* E* earlier document published on or after the international filing date	* Y	document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combinations being obvious to a person skilled in the art
* L* document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)	* Z	document member of the same patent family
* O* document referring to an oral disclosure, use, exhibition or other means		
* P* document published prior to the international filing date but later than the priority date claimed		

Date of the actual completion of the international search

12 OCTOBER 1995

Date of mailing of the international search report

24 OCT 1995

Name and mailing address of the ISA/US
Commissioner of Patents and Trademarks
Box PCT
Washington, D.C. 20231

Facsimile No. (703) 305-3230

Authorized officer

DAVID R. HUDSPETH

Telephone No. (703) 308-0956